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- Controlled Baseline

   One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -40°C to 100°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree<sup>†</sup>
- Advanced Multibus Architecture With Three Separate 16-Bit Data Memory Buses and One Program Memory Bus
- 40-Bit Arithmetic Logic Unit (ALU), Including a 40-Bit Barrel Shifter and Two Independent 40-Bit Accumulators
- 17-×17-Bit Parallel Multiplier Coupled to a 40-Bit Dedicated Adder for Non-Pipelined Single-Cycle Multiply/Accumulate (MAC) Operation
- Compare, Select, and Store Unit (CSSU) for the Add/Compare Selection of the Viterbi Operator
- Exponent Encoder to Compute an Exponent Value of a 40-Bit Accumulator Value in a Single Cycle
- Two Address Generators With Eight Auxiliary Registers and Two Auxiliary Register Arithmetic Units (ARAUs)
- Data Bus With a Bus-Holder Feature
- Extended Addressing Mode for 8M × 16-Bit Maximum Addressable External Program Space
- 16K x 16-Bit On-Chip ROM
- 32K x 16-Bit Dual-Access On-Chip RAM
- Single-Instruction-Repeat and Block-Repeat Operations for Program Code

- Block-Memory-Move Instructions for Better Program and Data Management
- Instructions With a 32-Bit Long Word Operand
- Instructions With Two- or Three-Operand Reads
- Arithmetic Instructions With Parallel Store and Parallel Load
- Conditional Store Instructions
- Fast Return From Interrupt
- On-Chip Peripherals
  - Software-Programmable Wait-State Generator and Programmable Bank Switching
  - On-Chip Phase-Locked Loop (PLL) Clock Generator With Internal Oscillator or External Clock Source
  - Three Multichannel Buffered Serial Ports (McBSPs)
  - Enhanced 8-Bit Parallel Host-Port Interface With 16-Bit Data/Addressing
  - One 16-Bit Timer
  - Six-Channel Direct Memory Access (DMA) Controller
- Power Consumption Control With IDLE1, IDLE2, and IDLE3 Instructions With Power-Down Modes
- CLKOUT Off Control to Disable CLKOUT
- On-Chip Scan-Based Emulation Logic, IEEE Std 1149.1<sup>‡</sup> (JTAG) Boundary Scan Logic
- 10-ns Single-Cycle Fixed-Point Instruction Execution Time (100 MIPS) for 3.3-V Power Supply (1.8-V Core)
- Available in a 144-Pin Ball Grid Array (BGA) (GGU Suffix)

**NOTE:** This data sheet is designed to be used in conjunction with the *TMS320C5000 DSP Family Functional Overview* (literature number SPRU307).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

- <sup>†</sup> Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.
- <sup>‡</sup> IEEE Standard 1149.1-1990 Standard-Test-Access Port and Boundary Scan Architecture.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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## description

The SM320VC5409-EP fixed-point, digital signal processor (DSP) (hereafter referred to as the '5409 unless otherwise specified) is based on an advanced modified Harvard architecture that has one program memory bus and three data memory buses. This processor provides an arithmetic logic unit (ALU) with a high degree of parallelism, application-specific hardware logic, on-chip memory, and additional on-chip peripherals. The basis of the operational flexibility and speed of this DSP is a highly specialized instruction set.

Separate program and data spaces allow simultaneous access to program instructions and data, providing the high degree of parallelism. Two read operations and one write operation can be performed in a single cycle. Instructions with parallel store and application-specific instructions can fully utilize this architecture. In addition, data can be transferred between data and program spaces. Such parallelism supports a powerful set of arithmetic, logic, and bit-manipulation operations that can all be performed in a single machine cycle. In addition, the '5409 includes the control mechanisms to manage interrupts, repeated operations, and function calls.

### **ORDERING INFORMATION**

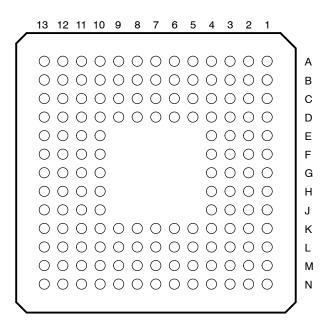
T <sub>A</sub>	PACKAGE <sup>‡</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 100°C	BGA – GGU	SM320VC5409GGU10EP	M5409GGUEP	

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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#### 320VC5409 GGU PACKAGE (BOTTOM VIEW)



The pin assignments table to follow lists each signal quadrant and BGA ball number for the SM320VC5409GGU (144-pin BGA package) which is footprint-compatible with the 'LC548, 'LC/VC549, and 'VC5410 devices.



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## Pin Assignments for the SM320VC5409GGU (144-Pin BGA Package)<sup>†</sup>

SIGNAL QUADRANT 1	BGA BALL #	SIGNAL QUADRANT 2	BGA BALL #	SIGNAL QUADRANT 3	BGA BALL #	SIGNAL QUADRANT 4	BGA BALL #
V <sub>SS</sub>	A1	BFSX1	N13	V <sub>SS</sub>	N1	A19	A13
A22	B1	BDX1	M13	BCLKR1	N2	A20	A12
V <sub>SS</sub>	C2	DV <sub>DD</sub>	L12	HCNTL0	M3	V <sub>SS</sub>	B11
DV <sub>DD</sub>	C1	V <sub>SS</sub>	L13	V <sub>SS</sub>	N3	DV <sub>DD</sub>	A11
A10	D4	CLKMD1	K10	BCLKR0	K4	D6	D10
HD7	D3	CLKMD2	K11	BCLKR2	L4	D7	C10
A11	D2	CLKMD3	K12	BFSR0	M4	D8	B10
A12	D1	HPI16	K13	BFSR2	N4	D9	A10
A13	E4	HD2	J10	BDR0	K5	D10	D9
A14	E3	TOUT	J11	HCNTL1	L5	D11	C9
A15	E2	EMU0	J12	BDR2	M5	D12	B9
CV <sub>DD</sub>	E1	EMU1/OFF	J13	BCLKX0	N5	HD4	A9
HAS	F4	TDO	H10	BCLKX2	K6	D13	D8
V <sub>SS</sub>	F3	TDI	H11	V <sub>SS</sub>	L6	D14	C8
V <sub>SS</sub>	F2	TRST	H12	HINT	M6	D15	B8
CV <sub>DD</sub>	F1	ТСК	H13	CV <sub>DD</sub>	N6	HD5	A8
HCS	G2	TMS	G12	BFSX0	M7	CV <sub>DD</sub>	B7
HR/W	G1	V <sub>SS</sub>	G13	BFSX2	N7	V <sub>SS</sub>	A7
READY	G3	CV <sub>DD</sub>	G11	HRDY	L7	HDS1	C7
PS	G4	HPIENA	G10	DV <sub>DD</sub>	K7	V <sub>SS</sub>	D7
DS	H1	V <sub>SS</sub>	F13	V <sub>SS</sub>	N8	HDS2	A6
IS	H2	CLKOUT	F12	HD0	M8	DV <sub>DD</sub>	B6
R/W	H3	HD3	F11	BDX0	L8	A0	C6
MSTRB	H4	X1	F10	BDX2	K8	A1	D6
IOSTRB	J1	X2/CLKIN	E13	IACK	N9	A2	A5
MSC	J2	RS	E12	HBIL	M9	A3	B5
XF	J3	D0	E11	NMI	L9	HD6	C5
HOLDA	J4	D1	E10	INTO	K9	A4	D5
IAQ	K1	D2	D13	INT1	N10	A5	A4
HOLD	K2	D3	D12	INT2	M10	A6	B4
BIO	КЗ	D4	D11	INT3	L10	A7	C4
MP/MC	L1	D5	C13	CV <sub>DD</sub>	N11	A8	A3
DV <sub>DD</sub>	L2			A9	B3		
V <sub>SS</sub>	L3	V <sub>SS</sub>	C11	V <sub>SS</sub>	L11	CV <sub>DD</sub>	C3
BDR1	 M1	A17	B13	BCLKX1	N12	A21	A2
BFSR1	M2	A18	B12	V <sub>SS</sub>	M12	V <sub>SS</sub>	B2

<sup>†</sup> DV<sub>DD</sub> is the power supply for the I/O pins while CV<sub>DD</sub> is the power supply for the core CPU. V<sub>SS</sub> is the ground for both the I/O pins and the core CPU.



## terminal functions

The '5409 signal descriptions table lists each pin name, function, and operating mode(s) for the '5409 device. Some of the '5409 pins can be configured for one of two functions; a primary function and a secondary function. The names of these pins in secondary mode are shaded in grey in the following table.

	MINAL AME	INTERNAL PIN STATE	I/O†	DESCRIPTION
				DATA SIGNALS
A22 A21 A20 A19 A18 A17 A16 A15 A14 A13 A12 A11 A10 A9 A8 A7 A6 A5 A4 A3 A2 A1 A0	(MSB) (LSB)	Bus holders available (A15–A0)	O/Z	Parallel address bus A22 [most significant bit (MSB)] through A0 [least significant bit (LSB)]. The lower sixteen address pins (A15 to A0) are multiplexed to address all external memory (program, data) or I/O while the upper seven address pins (A22 to A16) are only used to address external program space. These pins are placed in the high-impedance state when the hold mode is enabled, or when $\overline{\text{OFF}}$ is low.
D15 D14 D13 D12 D11 D9 D8 D7 D6 D5 D4 D5 D4 D3 D2 D1 D0	(MSB) (LSB)	Bus holders available	I/O/Z	Parallel data bus D15 (MSB) through D0 (LSB). The sixteen data pins (D15 to D0) are multiplexed to transfer data between the core CPU and external data/program memory or I/O devices. The data bus is placed in the high-impedance state when not outputting or when RS or HOLD is asserted. The data bus also goes into the high-impedance state when OFF is low. The data bus has bus holders to reduce the static power dissipation caused by floating, unused pins. These bus holders also eliminate the need for external bias resistors on unused pins. When the data bus is not being driven by the '5409, the bus holders keep the pins at the previous logic level. The data bus holders on the '5409 are disabled at reset and can be enabled/disabled via the BH bit of the bank-switching control register (BSCR).
			INI	IALIZATION, INTERRUPT, AND RESET OPERATIONS
IACK			O/Z	Interrupt acknowledge signal. IACK indicates receipt of an interrupt and that the program counter is fetching the interrupt vector location designated by A15–A0. IACK also goes into the high-impedance state when OFF is low.
INT0 INT1 INT2 INT3		Schmitt trigger	I	External user interrupts. INT0-INT3 are prioritized and are maskable by the interrupt mask register and the interrupt mode bit. INT0 -INT3 can be polled and reset by way of the interrupt flag register.

## **Terminal Functions**

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## **Terminal Functions (Continued)**

TERMINAL NAME	INTERNAL PIN STATE	I/O†	DESCRIPTION
	I	NITIALIZA	ATION, INTERRUPT, AND RESET OPERATIONS (CONTINUED)
NMI	Schmitt trigger	I	Nonmaskable interrupt. $\overline{\text{NMI}}$ is an external interrupt that cannot be masked by way of the INTM or the IMR. When $\overline{\text{NMI}}$ is activated, the processor traps to the appropriate vector location.
RS	Schmitt trigger	I	Reset. $\overline{\text{RS}}$ causes the DSP to terminate execution and causes a reinitialization of the CPU and peripherals. When $\overline{\text{RS}}$ is brought to a high level, execution begins at location 0FF80h of program memory. $\overline{\text{RS}}$ affects various registers and status bits.
MP/MC		I	Microprocessor/microcomputer mode select. If active low at reset, microcomputer mode is selected, and the internal program ROM is mapped into the upper program memory space. If the pin is driven high during reset, microprocessor mode is selected, and the on-chip ROM is removed from program space. MP/MC is only sampled at reset, and the MP/MC bit of the PMST register can override the mode that is selected at reset.
			MULTIPROCESSING SIGNALS
BIO	Schmitt trigger	I	Branch control. A branch can be conditionally executed when $\overline{\text{BIO}}$ is active. If low, the processor executes the conditional instruction. For the XC instruction, the $\overline{\text{BIO}}$ condition is sampled during the decode phase of the pipeline; all other instructions sample $\overline{\text{BIO}}$ during the read phase of the pipeline.
XF		O/Z	External flag output (latched software-programmable signal). XF is set high by the SSBX XF instruction, set low by the RSBX XF instruction or by loading ST1. XF is used for signaling other processors in multiprocessor configurations or used as a general-purpose output pin. XF goes into the high-impedance state when $\overline{OFF}$ is low, and is set high at reset.
			MEMORY CONTROL SIGNALS
DS PS IS		O/Z	Data, program, and I/O space select signals. $\overline{DS}$ , $\overline{PS}$ , and $\overline{IS}$ are always high unless driven low for accessing a particular external memory space. Active period corresponds to valid address information. $\overline{DS}$ , $\overline{PS}$ , and $\overline{IS}$ are placed into the high-impedance state in the hold mode; the signals also go into the high-impedance state when $\overline{OFF}$ is low.
MSTRB		O/Z	Memory strobe signal. MSTRB is always high unless low-level asserted to indicate an external bus access to data or program memory. MSTRB is placed in the high-impedance state in the hold mode; it also goes into the high-impedance state when OFF is low.
READY		I	Data ready. READY indicates that an external device is prepared for a bus transaction to be completed. If the device is not ready (READY is low), the processor waits one cycle and checks READY again. Note that the processor performs ready detection if at least two software wait states are programmed. The READY signal is not sampled until the completion of the software wait states.
R/W		O/Z	Read/write signal. R/ $\overline{W}$ indicates transfer direction during communication to an external device. R/ $\overline{W}$ is normally in the read mode (high), unless it is asserted low when the DSP performs a write operation. R/ $\overline{W}$ is placed in the high-impedance state in hold mode; it also goes into the high-impedance state when $\overline{OFF}$ is low.
IOSTRB		O/Z	I/O strobe signal. IOSTRB is always high unless low-level asserted to indicate an external bus access to an I/O device. IOSTRB is placed in the high-impedance state in the hold mode; it also goes into the high-impedance state when OFF is low.
HOLD		I	Hold. HOLD is asserted to request control of the address, data, and control lines. When acknowledged by the 'C54x, these lines go into the high-impedance state.
HOLDA		O/Z	Hold acknowledge. HOLDA indicates that the '5409 is in a hold state and that the address, data, and control lines are in the high-impedance state, allowing the external memory interface to be accessed by other devices. HOLDA also goes into the high-impedance state when OFF is low.
MSC		O/Z	Microstate complete. $\overline{\text{MSC}}$ indicates completion of all software wait states. When two or more software wait states are enabled, the $\overline{\text{MSC}}$ pin goes low during the last of these wait states. If connected to the READY input, $\overline{\text{MSC}}$ forces one external wait state after the last internal wait state is completed. $\overline{\text{MSC}}$ also goes into the high-impedance state when $\overline{\text{OFF}}$ is low.
ĪAQ		O/Z	Instruction acquisition signal. $\overline{IAQ}$ is asserted (active low) when there is an instruction address on the address bus. $\overline{IAQ}$ goes into the high-impedance state when $\overline{OFF}$ is low.



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## **Terminal Functions (Continued)**

TERMINAL NAME	INTERNAL PIN STATE	I/O†						
			OSCILLATOR/TIMER SIGNALS					
CLKOUT		O/Z	Master clock output signal. CLKOUT cycles at the machine-cycle rate of the CPU. The internal machine cycle is bounded by rising edges of this signal. CLKOUT also goes into the high-impedance state when OFF is low.					
CLKMD1 CLKMD2 CLKMD3	Schmitt trigger	I	Clock mode select signals. These inputs select the mode that the clock generator is initialized to after reset. The logic levels of CLKMD1–CLKMD3 are latched when the reset pin is low, and the clock mode register is initialized to the selected mode. After reset, the clock mode can be changed through software, but the clock mode select signals have no effect until the device is reset again.					
X2/CLKIN	Schmitt trigger	I	Clock/oscillator input. If the internal oscillator is not being used, X2/CLKIN functions as the clock input.					
X1		0	Output pin from the internal oscillator for the crystal. If the internal oscillator is not used, X1 should be left unconnected. X1 does not go into the high-impedance state when OFF is low.					
TOUT		O/Z	Timer output. TOUT signals a pulse when the on-chip timer counts down past zero. The pulse is one CLKOUT cycle wide. TOUT also goes into the high-impedance state when OFF is low.					
		N	ULTICHANNEL BUFFERED SERIAL PORT SIGNALS					
BCLKR0 BCLKR1 BCLKR2	Schmitt trigger	I/O/Z	Receive clocks. BCLKR serves as the serial shift clock for the buffered serial-port receiver. Input from an external clock source for clocking data into the McBSP. When not being used as a clock, these pins can be used as general-purpose I/O by setting RIOEN = 1. BCLKR can be configured as an output by the way of the CLKRM bit in the PCR register.					
BDR0 BDR1 BDR2		I	Buffered serial data receive (input) pin. When not being used as data-receive pins, these pins can be used as general-purpose I/O by setting RIOEN = 1.					
BFSR0 BFSR1 BFSR2		I/O/Z	Frame synchronization pin for buffered serial-port input data. The BFSR pulse initiates the receive-data process over the BDR pin. When not being used as data-receive synchronization pins, these pins can be used as general-purpose I/O by setting RIOEN = 1.					
BCLKX0 BCLKX1 BCLKX2	Schmitt trigger	I/O/Z	Transmit clocks. Clock signal used to clock data from the transmit register. This pin can also be configured as an input by setting the CLKXM = 0 in the PCR register. When not being used as a clock, these pins can be used as general-purpose I/O by setting XIOEN = 1. These pins are placed into the high-impedance state when OFF is low.					
BDX0 BDX1 BDX2		O/Z	Buffered serial-port transmit (output) pin. When not being used as data-transmit pins, these pins can be used as general-purpose I/O by setting XIOEN = 1.					
BFSX0 BFSX1 BFSX2		I/O/Z	These pins are placed into the high-impedance state when OFF is low. Buffered serial-port frame synchronization pin for transmitting data. The BFSX pulse initiates the transmit-data process over BDX pin. If $\overline{RS}$ is asserted when BFSX is configured as output, then BFSX is turned into input mode by the reset operation. When not being used as data-transmit synchronization pins, these pins can be used as general-purpose I/O by setting XIOEN = 1. These pins are placed into the high-impedance state when $\overline{OFF}$ is low.					



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## **Terminal Functions (Continued)**

TERMINAL NAME	INTERNAL PIN STATE	I/O†			DESCRIPTION			
			HOST-POR	T INTERF	ACE SIGNALS			
S	ECONDARY		PRIMARY					
HA15 – HA0	Bus holders available	I/O/Z	A15 – A0	O/Z	These pins can be used to address internal memory via the HPI when the HPI16 pin is high. The sixteen address pins, A15 to A0, are multiplexed to transfer address between the core CPU and external data/program memory, I/O devices, or HPI in 16-bit mode. The address bus includes bus holders to reduce the static power dissipation caused by floating, unused pins. The bus holders also eliminate the need for external bias resistors on unused pins. When the address bus is not being driven by the '5409, the bus holders keep the pins at the logic level that was most recently driven. The address bus holders of the '5409 are disabled at reset, and can be enabled/disabled via the HBH bit of the BSCR.			
HD15 – HD0	Bus holders available	I/O/Z	D15 – D0	O/Z	These pins can be used to read/write internal memory via the HPI when the HPI16 pin is high. The sixteen data pins, D15 to D0, are multiplexed to transfer data between the core CPU and external data/program memory, I/O devices, or HPI in 16-bit mode. The data bus is placed in the high-impedance state when not outputting or when RS or HOLD is asserted. The data bus also goes into the high-impedance state when OFF is low. The data bus includes bus holders to reduce the static power dissipation caused by floating, unused pins. The bus holders also eliminate the need for external bias resistors on unused pins. When the data bus is not being driven by the '5409, the bus holders keep the pins at the logic level that was most recently driven. The data bus holders of the '5409 are disabled at reset, and can be enabled/disabled via the BH bit of the BSCR.			
HD7 – HD0	Bus holders available	I/O/Z	can also be used as when not outputting The HPI data bus ir unused pins. When at the logic level tha 8-bit mode the bus	s general-p g data or v ncludes bu the HPI da tt was mos holders ca	When the HPI is disabled or when the HPI16 pin is high, these pins burpose I/O pins. HD7–HD0 are placed in the high-impedance state when OFF is low. It has holders to reduce the static power dissipation caused by floating, ata bus is not being driven by the '5409, the bus holders keep the pins st recently driven. The HPI data bus holders are disabled at reset. In an be enabled/disabled via the HBH bit of the BSCR. In 16-bit mode ctive on the HD7–HD0 pins.			
HCNTL0 HCNTL1	Pullup resistor	Ι			1 select a host access to one of the three HPI registers. The control sistors that are only enabled when HPIENA = 0.			
HBIL	Pullup resistor	I	Byte identification. HBIL identifies the first or second byte of transfer. The HBIL input has a pullup resistor that is only enabled when HPIENA = 0.					
HCS	Schmitt trigger/pullup resistor	I	Chip select. HCS is the select input for the HPI and must be driven low during accesses. The chip-select input has an internal pullup resistor that is only enabled when HPIENA = 0.					
HDS1 HDS2	Schmitt trigger/pullup resistor	I	Data strobe. HDS1 and HDS2 are driven by the host read and write strobes to control transfers. The strobe inputs have internal pullup resistors that are only enabled when HPIENA = 0.					
HAS	Schmitt trigger/pullup resistor	I			ultiplexed address and data pins require $\overline{\text{HAS}}$ to latch the address in In internal pullup resistor that is only enabled when HPIENA = 0.			



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## **Terminal Functions (Continued)**

TERMINAL NAME	INTERNAL PIN STATE	I/O†	DESCRIPTION				
			HOST-PORT INTERFACE SIGNALS (CONTINUED)				
HR/W	Pullup resistor	I	Read/write. HR/ $\overline{W}$ controls the direction of an HPI transfer. R/ $\overline{W}$ has an internal pullup resistor that is only enabled when HPIENA = 0.				
HRDY		O/Z	Ready. The ready output informs the host when the HPI is ready for the next transfer. HRDY goes into the high-impedance state when $\overline{\text{OFF}}$ is low.				
HINT		O/Z	Interrupt. This output is used to interrupt the host. When the DSP is in reset, HINT is driven high. The signal goes into the high-impedance state when OFF is low.				
HPIENA	Pulldown resistor	I	HPI module select. HPIENA must be driven high during reset to enable the HPI. An internal pulldown resistor is always active and the HPIENA pin is sampled on the rising edge of $\overline{\text{RS}}$ . If HPIENA is left open or is driven low during reset, the HPI module is disabled. Once the HPI is disabled, the HPIENA pin has no effect until the '5409 is reset.				
HPI16	Pulldown resistor	I	HPI 16-bit select pin (internal pulldown, default HPI8). HPI16 = 1 selects the non-multiplexed mode. The non-multiplexed mode allows hosts with separate address/data buses to access the HPI address range via the 16 address pins (A15–A0). 16-bit data is also accessible through pins D0 through D15. Host-to-DSP and DSP-to-Host interrupts are not supported. There are no HPIC and HPIA register accesses in the non-multiplexed mode.				
			The HPI16 pin is sampled at RESET. The user should never change the value of the HPI16 pin while the RESET signal is HIGH.				
			SUPPLY PINS				
CV <sub>DD</sub>		S	+V <sub>DD</sub> . Dedicated 1.8-V power supply for the core CPU				
DV <sub>DD</sub>		S	+V <sub>DD</sub> . Dedicated 3.3-V power supply for the I/O pins				
V <sub>SS</sub>		S	Ground				
			TEST PINS				
тск	Schmitt trigger/pullup resistor	I	IEEE standard 1149.1 test clock. TCK is normally a free-running clock signal with a 50% duty cycle. The changes on the test access port (TAP) of input signals TMS and TDI are clocked into the TAP controller, instruction register, or selected test data register on the rising edge of TCK. Changes at the TAP output signal (TDO) occur on the falling edge of TCK.				
TDI	Pullup resistor	I	IEEE standard 1149.1 test data input pin with internal pullup device. TDI is clocked into the selected register (instruction or data) on a rising edge of TCK.				
TDO		O/Z	IEEE standard 1149.1 test data output. The contents of the selected register (instruction or data) are shifted out of TDO on the falling edge of TCK. TDO is in the high-impedance state except when the scanning of data is in progress. TDO also goes into the high-impedance state when OFF is low.				
TMS	Pullup resistor	I	IEEE standard 1149.1 test mode select. Pin with internal pullup device. This serial control input is clocked into the TAP controller on the rising edge of TCK.				
TRST	Pulldown resistor	I	IEEE standard 1149.1 test reset. TRST, when high, gives the IEEE standard 1149.1 scan system control of the operations of the device. If TRST is not connected or is driven low, the device operates in its functional mode, and the IEEE standard 1149.1 signals are ignored. Pin with internal pulldowr device.				



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## **Terminal Functions (Continued)**

TERMINAL NAME	INTERNAL PIN STATE	I/O†	DESCRIPTION					
	TEST PINS (CONTINUED)							
EMU0		I/O/Z	Emulator 0 pin. When $\overline{\text{TRST}}$ is driven low, EMU0 must be high for activation of the $\overline{\text{OFF}}$ condition. When $\overline{\text{TRST}}$ is driven high, EMU0 is used as an interrupt to or from the emulator system and is defined as input/output by way of the IEEE standard 1149.1 scan system.					
EMU1/OFF		I/O/Z	Emulator 1 pin/disable all outputs. When TRST is driven high, EMU1/OFF is used as an interrupt to or from the emulator system and is defined as input/output by way of the IEEE standard 1149.1 scan system. When TRST is driven low, EMU1/OFF is configured as OFF. The EMU1/OFF signal, when active low, puts all output drivers into the high-impedance state. Note that OFF is used exclusively for testing and emulation purposes (not for multiprocessing applications). Therefore, for the OFF feature, the following apply: TRST = low EMU0 = high EMU1/OFF = low					

<sup>†</sup> I = Input, O = Output, Z = High-impedance, S = Supply

#### memory

The '5409 device provides both on-chip ROM and RAM memories to aid in system performance and integration.

### on-chip ROM with bootloader

A bootloader is available in the standard '5409 on-chip ROM. This bootloader can be used to automatically transfer user code from an external source to anywhere in the program memory at power up. If the MP/MC pin is sampled low during a hardware reset, execution begins at location FF80h of the on-chip ROM. This location contains a branch instruction to the start of the bootloader program. The standard '5409 bootloader provides different ways to download the code to accommodate various system requirements:

- Parallel from 8-bit or 16-bit-wide EPROM
- Parallel from I/O space 8-bit or 16-bit mode
- Serial boot from serial ports 8-bit or 16-bit mode
- Host-port interface boot
- SPI serial EEPROM 8-bit boot mode

The standard on-chip ROM layout is shown in Table 1.

### on-chip memory security

The '5409 features a 16K-word  $\times$  16-bit on-chip maskable ROM. Customers can arrange to have the ROM of the '5409 programmed with contents unique to any particular application. A security option is available to protect a custom ROM. The ROM and ROM/RAM security options are available on the '5409. These security options are described in the *TMS320C54x DSP CPU and Peripherals Reference Set, Volume 1* (literature number SPRU131). When the security options are enabled, JTAG emulation is inhibited or nonfunctional.



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### on-chip ROM with bootloader (continued)

## Table 1. Standard On-Chip ROM Layout<sup>†</sup>

ADDRESS RANGE	DESCRIPTION
0x0000h – 0xBFFFh	External program space
0xC000h – 0xF7FFh	Reserved
0xF800h – 0xFBFFh	Bootloader
0xFC00h – 0xFEFFh	Reserved
0xFF00h – 0xFF7Fh	Reserved <sup>†</sup>
0xFF80h – 0xFFFFh	Interrupt vector table

<sup>†</sup> In the 'VC5409 ROM, 128 words are reserved for factory device-testing purposes. Application code to be implemented in on-chip ROM must reserve these 128 words at addresses FF00h–FF7Fh in program space.

#### on-chip RAM

The '5409 device contains  $32K \times 16$ -bit of on-chip dual-access RAM (DARAM). The DARAM is composed of four blocks of 8K words each. Each block in the DARAM can support two reads in one cycle, or a read and a write in one cycle. The DARAM is located in the address range 0080h–7FFFh in data space, and can be mapped into program/data space by setting the OVLY bit to one.



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#### memory map

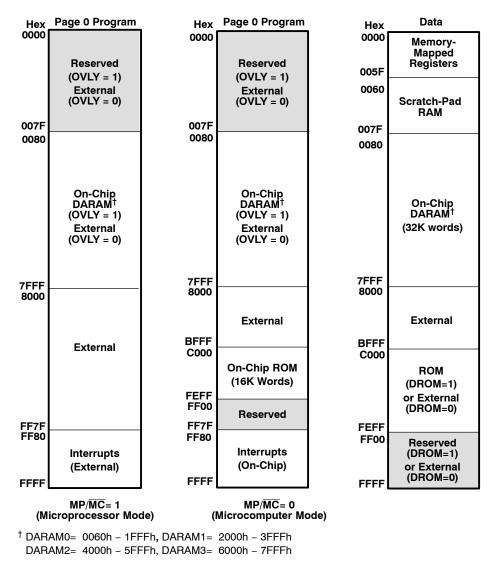


Figure 1. Memory Map

### relocatable interrupt vector table

The reset, interrupt, and trap vectors are addressed in program space. These vectors are soft — meaning that the processor, when taking the trap, loads the program counter (PC) with the trap address and executes the code at the vector location. Four words are reserved at each vector location to accommodate a delayed branch instruction, either two 1-word instructions or one 2-word instruction, which allows branching to the appropriate interrupt service routine with minimal overhead.

At device reset, the reset, interrupt, and trap vectors are mapped to address FF80h in program space. However, these vectors can be remapped to the beginning of any 128-word page in program space after device reset. This is done by loading the interrupt vector pointer (IPTR) bits in the PMST register with the appropriate 128-word page boundary address. After loading IPTR, any user interrupt or trap vector is mapped to the new 128-word page.

**NOTE:**The hardware reset (RS) vector cannot be remapped because a hardware reset loads the IPTR with 1s. Therefore, the reset vector is always fetched at location FF80h in program space.



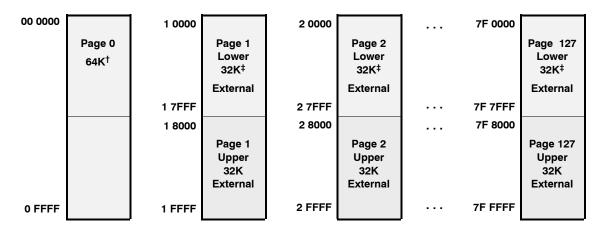
#### extended program memory

The '5409 CPU uses a paged extended memory scheme in program space to allow access of up to 8M program memory locations. In order to implement this scheme, the '5409 includes several features that are also present on the '548/'549 devices:

- Twenty-three address lines, instead of sixteen
- An extra memory-mapped register, the XPC register defines the page selection. This register is memory-mapped into data space to address 001Eh. At a hardware reset, the XPC is initialized to 0.
- Six extra instructions for addressing extended program space. These six instructions affect the XPC.
  - FB[D] pmad (23 bits) Far branch
  - FBACC[D] Accu[22:0] Far branch to the location specified by the value in accumulator A or accumulator B
  - FCALL[D] pmad (23 bits) Far call
  - FCALA[D]Accu[22:0] Far call to the location specified by the value in accumulator A or accumulator B
  - FRET[D] Far return
  - FRETE[D] Far return with interrupts enabled
- In addition to these new instructions, two '54x instructions are extended to use 23 bits in the '5409:
  - READA data\_memory (using 23-bit accumulator address)
  - WRITA data\_memory (using 23-bit accumulator address)

All other instructions, software interrupts, and hardware interrupts do not modify the XPC register and access only memory within the current page.

Program memory in the '5409 is organized into 127 pages that are each 64K in length, as shown in Figure 2.



<sup>†</sup> Refer to Figure 1. 5409 Memory Map.

<sup>‡</sup> The Lower 32K words of pages 1 through 126 are available only when the OVLY bit is cleared to 0. If the OVLY bit is set to 1, the on-chip RAM is mapped to the lower 32K words of all program space pages.

## Figure 2. Extended Program Memory



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## on-chip peripherals

The '5409 device has the following peripherals:

- Software-programmable wait-state generator with programmable bank-switching wait states
- An enhanced 8-bit host-port interface (HPI8/16) with 16-bit data/addressing
- Three multichannel buffered serial ports (McBSPs)
- One hardware timer
- A clock generator with a phase-locked loop (PLL)
- A direct memory access (DMA) controller

### software-programmable wait-state generator

The software wait-state generator of the '5409 is similar to that of the '5410 and it can extend external bus cycles by up to fourteen machine cycles. Devices that require more than fourteen wait states can be interfaced using the hardware READY line. When all external accesses are configured for zero wait states, the internal clocks to the wait-state generator are automatically disabled. Disabling the wait-state generator clocks reduces the power consumption of the '5409.

The software wait-state register (SWWSR) controls the operation of the wait-state generator. The 14 LSBs of the SWWSR specify the number of wait states (0 to 7) to be inserted for external memory accesses to five separate address ranges. This allows a different number of wait states for each of the five address ranges. Additionally, the software wait-state multiplier (SWSM) bit of the system configuration register (SCR) defines a multiplication factor of 1 or 2 for the number of wait states. At reset, the wait-state generator is initialized to provide seven wait states on all external memory accesses. The SWWSR bit fields are shown in Figure 3 and described in Table 2.

15	14	12	11	9	8		6	5	3	2	0
XPA	I/C	)		Data		Data		Program	n	Program	I
R/W-0	R/W	-111		R/W-111		R/W-111		R/W-11	1	R/W-111	



## Figure 3. Software Wait-State Register (SWWSR) [Memory-Mapped Register (MMR) Address 0028h]



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## software-programmable wait-state generator (continued)

	BIT RESE		FUNCTION						
NO.	NAME	VALUE	FUNCTION						
15	XPA	0	Extended program address control bit. XPA is used in conjunction with the program space fields (bits 0 through 5) to select the address range for program space wait states.						
14–12	I/O	1	I/O space. The field value (0–7) corresponds to the base number of wait states for I/O space accesses within addresses 0000–FFFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.						
11–9	Data	1	Upper data space. The field value (0–7) corresponds to the base number of wait states for external data space accesses within addresses 8000–FFFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.						
8–6	Data	1	Lower data space. The field value (0–7) corresponds to the base number of wait states for external data space accesses within addresses 0000–7FFFh. The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.						
5–3	5–3 Program <sup>·</sup>	ım 1	<ul> <li>Upper program space. The field value (0-7) corresponds to the base number of wait states for external program space accesses within the following addresses:</li> <li>XPA = 0: x8000 - xFFFFh</li> <li>XPA = 1: The upper program space bit field has no effect on wait states.</li> </ul>						
			The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.						
			Program space. The field value (0-7) corresponds to the base number of wait states for external program space accesses within the following addresses:						
2-0	Program	1	□ XPA = 0: x0000-x7FFFh						
	. rogram		☐ XPA = 1: 00000-FFFFFh						
			The SWSM bit of the SWCR defines a multiplication factor of 1 or 2 for the base number of wait states.						

### Table 2. Software Wait-State Register (SWWSR) Bit Fields

The software wait-state multiplier bit of the software wait-state configuration register is used to extend the base number of wait states selected by the SWWSR. The SWCR bit fields are shown in Figure 4 and described in Table 3.

15		1	0
	Reserved		SWSM
	R/W-0		R/W-0

**LEGEND:** R = Read, W = Write

Figure 4. Software Wait-State Configuration Register (SWCR) [MMR Address 002Bh]

Table 3. Software Wait-State	Configuration Register	(SWCR) Bit Fields
	ooninguration negister	

	PIN	RESET	FUNCTION						
NO.	NAME	VALUE	FUNCTION						
15–1	Reserved	0	hese bits are reserved and are unaffected by writes.						
0	SWSM	0	<ul> <li>Software wait-state multiplier. Used to multiply the number of wait states defined in the SWWSR by a factor of 1 or 2.</li> <li>SWSM = 0: wait-state base values are unchanged (multiplied by 1).</li> <li>SWSM = 1: wait-state base values are multiplied by 2 for a maximum of 14 wait states.</li> </ul>						



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### programmable bank-switching wait states

The programmable bank-switching logic of the '5409 is functionally equivalent to that of the '548/'549 devices. This feature automatically inserts one cycle when accesses cross memory-bank boundaries within program or data memory space. A bank-switching wait state can also be automatically inserted when accesses cross the data space boundary into program space.

The bank-switching control register (BSCR) defines the bank size for bank-switching wait-states. Figure 5 shows the BSCR and its bits are described in Table 4.

15	12	11	10	3	2	1	0	
BNK	CMP	PS-DS	Reserved		НВН	BH	EXIO	
R/W-1111 R/W-1		R/W-1	R-0		R/W-0	R/W-0	R/W-0	

LEGEND: R = Read, W = Write

### Figure 5. Bank-Switching Control Register (BSCR) [MMR Address 0029h]

NO.	BIT NAME	RESET VALUE	FUNCTION				
15–12	BNKCMP	1111	Bank compare. BNKCMP determines the external memory-bank size. BNKCMP is used to mask the four MSBs of an address. For example, if BNKCMP = 1111b, the four MSBs (bits 12–15) are compared, resulting in a bank size of 4K words. Bank sizes of 4K words to 64K words are allowed.				
11	PS-DS	1	Program read - data read access. PS-DS inserts an extra cycle between consecutive accesses of programread and data read or data read and program read.PS-DS = 0No extra cycles are inserted by this feature.PS-DS = 1One extra cycle is inserted between consecutive data and program reads.				
10–3	Reserved	0	hese bits are reserved and are unaffected by writes.				
2	НВН	0	HPI bus holder. HBH controls the HPI bus holder feature. HBH is cleared to 0 at reset.         8-bit Mode         HBH = 0       The bus holder is disabled for the HPI data bus (HD[7:0]).         HBH = 1       The bus holders are enabled on HD[7:0]. When not driven, the HPI data bus (HD[7:0]) is held in the previous logic level.         HPI bus holder.       HBH controls the HPI bus holder feature. HBH is cleared to 0 at reset.         16-bit Mode       The bus holder is disabled for the HPI address bus (HA[15:0]). The HPI GPIO pins (HD[7:0]) are held in the previous logic level.         HBH = 0       The bus holder are enabled on HA[15:0]. When not driven, the HPI address bus (A[15:0]) and HPI GPIO pins (HD[7:0]) are held in the previous logic level.				
1	BH	0	Bus holder. BH controls the data bus holder feature. BH is cleared to 0 at reset.BH = 0The bus holder is disabled.BH = 1The bus holder is enabled. When not driven, the data bus (D[15:0]) is held in the previous logic level.				
0	EXIO	0	External bus interface off. The EXIO bit controls the external bus-off function.         EXIO = 0       The external bus interface functions as usual.         EXIO = 1       The address bus, data bus, and control signals become inactive after completing the current bus cycle. Note that the DROM, MP/MC, and OVLY bits in the PMST and the HM bit of ST1 cannot be modified when the interface is disabled.				

### Table 4. Bank-Switching Control Register Fields



### parallel I/O ports

The '5409 CPU has a total of 64K I/O ports. These ports can be addressed by the PORTR instruction or the PORTW instruction. The IS signal indicates a read/write operation through an I/O port. The '5409 can interface easily with external devices through the I/O ports while requiring minimal off-chip address-decoding circuits.

#### enhanced 8-bit host-port interface (HPI8/16)

The '5409 host-port interface, also referred to as the HPI8/16, is an enhanced version of the standard 8-bit HPI found on earlier '54x DSPs ('542, '545, '548, and '549). The HPI8/16 is an 8-bit parallel port for interprocessor communication. The features of the HPI8/16 include:

Standard features:

- Sequential transfers (with autoincrement) or random-access transfers
- Host interrupt and '54x interrupt capability
- Multiple data strobes and control pins for interface flexibility

Enhanced features of the '5409 HPI8/16:

- Access to entire on-chip RAM through DMA bus
- Capability to continue transferring during emulation stop
- Capability to transfer 16-bit address and 16-bit data (non-multiplexed mode)

The HPI8/16 functions as a slave and enables the host processor to access the on-chip memory of the '5409. A major enhancement to the '5409 HPI over previous versions is that it allows host access to the entire on-chip memory range of the DSP. The HPI8/16 does not have access to external memory. The host and the DSP both have access to the on-chip RAM at all times and host accesses are always synchronized to the DSP clock. If the host and the DSP contend for access to the same location, the host has priority, and the DSP waits for one HPI8/16 cycle. Note that since host accesses are always synchronized to the '5409 clock, an active input clock (CLKIN) is required for HPI8/16 accesses during IDLE states, and host accesses are not allowed while the '5409 reset pin is asserted.

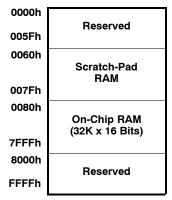


Figure 6. '5409 HPI Memory Map

#### standard 8-bit mode

The HPI8/16 interface consists of an 8-bit bidirectional data bus and various control signals. Sixteen-bit transfers are accomplished in two parts with the HBIL input designating high or low byte. The host communicates with the HPI8 through three dedicated registers — HPI address register (HPIA), HPI data register (HPID), and an HPI control register (HPIC). The HPIA and HPID registers are only accessible by the host, and the HPIC register is accessible by both the host and the '5409. If the HPI is disabled (HPIENA = 0) or in HPI16 mode (HPI16 = 1), the 8-bit bidirectional data pins HD0–HD7 can be used as general-purpose input/output (GPIO).



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#### 16-bit nonmultiplexed mode

In *nonmultiplexed* mode, a host with separate address/data buses can access the HPI16 data register (HPID) via the HD 16-bit bidirectional data bus, and the address register (HPIA) via the 16-bit HA address bus, external address and data pins, A0–A15 and D0–D15, respectively. The host initiates an access with the strobe signals (HDS1, HDS2, HCS) and controls the direction of the access with the HR/W signal. The HPI16 can stall host accesses via the HRDY signal. Note that the HPIC register is not available in *nonmultiplexed* mode since there are no HCNTL signals available. All host accesses initiate a DMA read or write access. The HPI16 nonmultiplexed mode does not support host-to-DSP and DSP-to-host interrupts. When the HPI is disabled or in HPI16 mode, HD0–HD7 can be configured as general-purpose input/output (GPIO). The HPI16 pin is sampled at RESET. The HPI16 pin should never be changed while the device RESET is HIGH.

#### host bus holder configuration

The '5409 has two bus holder control bits, BH (BSCR[1]) and HBH (BSCR[2]), to control the bus keepers of the address bus (A[15–0]), data bus (D[15–0]) and the HPI data bus (HD[7–0]). The bus keeper enabling/disabling is described in Table 5.

HPI16 pin	вн	НВН	D[15–0]	A[15–0]	HD[7-0]
0	0	0	OFF	OFF	OFF
0	0	1	OFF	OFF	ON
0	1	0	ON	OFF	OFF
0	1	1	ON	OFF	ON
1	0	0	OFF	OFF	ON
1	0	1	OFF	ON	ON
1	1	0	ON	OFF	ON
1	1	1	ON	ON	ON

### Table 5. Bus Holder Control Bits

The HPI bus holders are activated via the HBH bit in the Bank Switch Control Register (BSCR). The HBH bit can control bus holder behavior for both the 8-bit and 16-bit modes. In the 8-bit mode, the HBH bit controls the bus holders on the host data pins HD7–HD0. When HBH = 1, the host data bus holders are active. When HBH = 0 the host data bus holders are inactive. In the 16-bit nonmultiplexed mode, the bus holders for pins HD7–HD0 are always active; however, the HBH bit controls the host address pins A15–A0. When HBH = 1, the host address bus holders are active. When HBH = 0, the host address bus holders are inactive.

## operation during IDLE2

The HPI can continue to operate during IDLE1 or IDLE2 by using special clock management logic that turns on relevant clocks to perform a synchronous memory access, and then turns the clocks back off to save power. The DSP CPU does not wake up from the IDLE mode during this process.



### multichannel buffered serial ports (McBSPs)

The '5409 device has three high-speed, full-duplex multichannel buffered serial ports (McBSPs) that allow direct interface to other 'C54x/'LC54x devices, Codecs, and other devices in a system. The McBSPs are based on the standard serial port interface found on other '54x devices. Like its predecessors, the McBSP provides:

- Full-duplex communication
- Double-buffer data registers, which allow a continuous data stream
- Independent framing and clocking for receive and transmit

In addition, the McBSP has the following capabilities:

- Direct interface to:
  - T1/E1 framers
  - MVIP switching-compatible and ST-BUS compliant devices
  - IOM-2 compliant devices
  - AC97-compliant devices
  - Serial peripheral interface (SPI™) devices
- Multichannel transmit and receive of up to 32 channels in a 128 channel stream.
- A wide selection of data sizes including 8, 12, 16, 20, 24, or 32 bits
- μ-law and A-law companding
- Programmable polarity for both frame synchronization and data clocks
- Programmable internal clock and frame generation

For detailed information on the standard features of the McBSP, refer to the *TMS320C54x DSP Enhanced Peripherals Reference Set*, literature number SPRU302.

Although the BCLKS pin is not available on the '5409 PGE and GGU packages, the '5409 is capable of synchronization to external clock sources. BCLKX or BCLKR can be used by the sample rate generator for external synchronization. The sample rate clock mode extended (SCLKME) bit field is located in the PCR to accommodate this option.

15	14	13	12	12 11 1		9	8
Res	erved	XIOEN	RIOEN	FSXM	FSRM	CLKXM	CLKRM
RW		RW	RW	RW RW RW		RW	RW
7	7 6		4	3	2	1	0
SCLKME	CLKS STAT	DX STAT	DR STAT	FSXP	FSRP	CLKXP	CLKRP
RW	RW	RW	RW	RW	RW	RW	RW

LEGEND: R = Read, W = Write

### Figure 7. Pin Control Register (PCR)



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## multichannel buffered serial ports (McBSPs) (continued)

## Table 6. Pin Control Register (PCR) Bit Field Description

BIT	NAME	FUNCTION							
15 – 14	Reserved	Reserved. Pin	s are not used.						
		Transmit/Receive general-purpose I/O mode ONLY when XRST=0 in the SPCR(1/2)							
13	XIOEN	XIOEN = 0 XIOEN = 1	DX pin is not a general-purpose output. FSX and CLKX are not general-purpose I/Os. DX pin is a general-purpose output. FSX and CLKX are general-purpose I/Os. These serial port pins do not perform serial port operations.						
		Transmit/Rece	eive general-purpose I/O mode ONLY when RRST=0 in the SPCR(1/2)						
12	RIOEN	RIOEN = 0	DR and CLKS pins are not general-purpose inputs. FSR and CLKR are not general-purpose I/Os.						
		RIOEN = 1	DR and CLKS pins are general-purpose inputs. FSR and CLKR are general-purpose I/Os. These serial port pins do not perform serial port operations. The CLKS pin is affected by a combination of RRST and RIOEN signals of the receiver.						
		Transmit fram	e synchronization mode						
11	FSXM	FSRM = 0Frame synchronization signal derived from an external source.FSRM = 1Frame synchronization is determined by the sample rate generator frame synchronibit (FSGM) in the SRGR2.							
		Receive frame	e synchronization mode						
10	FSRM	FSRM = 0 FSRM = 1	Frame synchronization pulses generated by an external device. FSR is an input pin. Frame synchronization generated internally by the sample rate generator. FSR is an output pin except when GSYNC=1 in the SRGR.						
		Receiver clock	< mode						
		Case 1: Digita	l loop-back mode is not set (DLB=0) in SPCR1.						
		CLKRM = 0 CLKRM= 1	Receive clock (CLKR) is an input pin driven by an external clock. CLKR is an output pin and is driven by the internal sample rate generator						
9	CLKRM	Case 2: Digita	I loop-back mode set (DLB=1) in SPCR1						
		CLKRM = 0	Receive clock ( <i>Not</i> the CLKR pin) is driven by transmit clock (CLKX), which is based on CLKXM bit in the PCR. CLKR pin is in high-impedance mode.						
		CLKRM= 1	CLKR is an output pin and is driven by the transmit clock. The transmit clock is derived based on the CLKXM bit in the PCR.						
		Transmitter clo	ock mode						
		Receiver/transmitter clock is driven by an external clock with $CLK(R/X)$ as an input pin $CLK(R/X)$ is an output pin and is driven by the internal sample rate generator							
8	CLKXM	During SPI mo	ode (CLKSTP is a non-zero value):						
	CLKXM = 0 McBSP is a slave and clock (CLKX) is driven by the SPI master in the system internally driven by CLKX.								
		CLKXM= 1	McBSP is a master and generates the clock (CLKX) to drive its receive clock (CLKR) and the shift clock of the SPI-compliant slaves in the system.						



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## multichannel buffered serial ports (McBSPs) (continued)

BIT	NAME	FUNCTION								
		Sample rate clock mode extended								
7	SCLKME	SCLKME = 0External clock via CLKS or CPU clock is used as a reference by the sample rate generator.SCLKME = 1External clock via CLKR or CLKX clock is used as a reference by the sample rate generator.								
6	CLKS STAT	CLKS pin status. CLKS STAT reflects value on CLKS pin when selected as a general-purpose input.								
5	DX STAT	DX pin status. DX STAT reflects value on DX pin when it is selected as a general-purpose output.								
4	DR STAT	DR pin status. DR STAT reflects value on DR pin when it is selected as a general-purpose input.								
	FSXP FSRP	Receive/Transmit frame synchronization polarity.								
3 – 2		FS(R/X)P = 0 Frame synchronization pulse FS(R/X) is active high FS(R/X)P = 1 Frame synchronization pulse FS(R/X) is active low								
		Transmit clock polarity								
1	CLKXP	CLKXP = 0Transmit data sampled on rising edge of CLKRCLKXP = 1Transmit data sampled on falling edge of CLKR								
		Receive clock polarity								
0	CLKRP	CLKRP = 0Receive data sampled on falling edge of CLKRCLKRP = 1Receive data sampled on rising edge of CLKR								

The '5409 sample rate generator has four clock input options that are only available when both the PCR and SRGR2 are used. Table 7 shows the sample rate generator clock input options.

			MODE		MODE		MODE				.KME CR.7)			CLKSM RGR2.1					
			CLKS pin		CLKS pir			(	0			0							
			CPU	٧U		0			1										
			CLKR pi	n	n 1			0											
			CLKX pi	n			1		1										
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0				
GSYNC	CLKSP	CLKSM	FSGM		FPER														
RW	RW	RW	RW		RW														

LEGEND: R = Read, W = Write

## Figure 8. Sample Rate Generator Register 2 (SRGR2)



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## multichannel buffered serial ports (McBSPs) (continued)

## Table 8. Sample Rate Generator Register 2 (SRGR2) Bit Field Descriptions

BIT	NAME	FUNCTION					
		Sample rate ge generator clock	,	nronization. Only used when the external clock (CLKS) drives the sample rate			
15	GSYNC	GSYNC = 0       The sample rate generator clock (CLKG) is free-running.         GSYNC = 1       The sample rate generator clock (CLKG) is running. But CLKG is resynchronized and frame synchronization signal (FSG) is generated only after detecting the receive frame synchronization signal (FSR). Also frame period (FPER) is a don't care because the period is dictated by the external frame sync pulse					
14	CLKSP	CLKS polarity clock edge select. Only used when the external clock (CLKS) drives the sample rate generator clock (CLKSM=0).					
14	OLIVOI	CLKSP = 0 CLKSP = 1	5 5 5				
		McBSP sample	rate generator cloo	ck mode			
13	CLKSM	SCLKME = 0 (in PCR)	CLKSM = 0 CLKSM = 1	Sample rate generator clock derived from the CLKS pin Sample rate generator clock derived from CPU clock			
		SCLKME = 1 (in PCR)	CLKSM = 0 CLKSM = 1	Sample rate generator clock derived from CLKR pin Sample rate generator clock derived from CLKX pin			
		Sample rate ge	nerator transmit fra	me synchronization mode. Used when FSXM=1 in the PCR.			
12	FSGM	FSGM = 0 FSGN = 1		rnc signal (FSX) due to DXR(1/2) copy rnc signal driven by the sample rate generator frame sync signal (FSG)			
11 – 0	FPER	Frame period. 1 to 4096 CLKC		when the next frame sycn signal should become active. Range: up to 2 <sup>12</sup> ;			

#### hardware timer

The '5409 device features one 16-bit timing circuit with a 4-bit prescaler. The main counter of each timer is decremented by one every CLKOUT cycle. Each time the counter decrements to 0, a timer interrupt is generated. The timer can be stopped, restarted, reset, or disabled by specific control bits.

### clock generator

The clock generator provides clocks to the '5409 device, and consists of an internal oscillator and a phase-locked loop (PLL) circuit. The clock generator requires a reference clock input, which can be provided by using a crystal resonator with the internal oscillator, or from an external clock source. The reference clock input is then divided by two (DIV mode) to generate clocks for the '5409 device, or the PLL circuit can be used (PLL mode) to generate the device clock by multiplying the reference clock frequency by a scale factor, allowing use of a clock source with a lower frequency than that of the CPU. The PLL is an adaptive circuit that, once synchronized, locks onto and tracks an input clock signal.



#### clock generator (continued)

When the PLL is initially started, it enters a transitional mode during which the PLL acquires lock with the input signal. Once the PLL is locked, it continues to track and maintain synchronization with the input signal. Then, other internal clock circuitry allows the synthesis of new clock frequencies for use as master clock for the '5409 device.

This clock generator allows system designers to select the clock source. The sources that drive the clock generator are:

- A crystal resonator circuit. The crystal resonator circuit is connected across the X1 and X2/CLKIN pins of the '5409 to enable the internal oscillator.
- An external clock. The external clock source is directly connected to the X2/CLKIN pin, and X1 is left unconnected.

The software-programmable PLL features a high level of flexibility, and includes a clock scaler that provides various clock multiplier ratios, capability to directly enable and disable the PLL, and a PLL lock timer that can be used to delay switching to PLL clocking mode of the device until lock is achieved. Devices that have a built-in software-programmable PLL can be configured in one of two clock modes:

- PLL mode. The input clock (X2/CLKIN) is multiplied by 1 of 31 possible ratios. These ratios are achieved using the PLL circuitry.
- DIV (divider) mode. The input clock is divided by 2 or 4. Note that when DIV mode is used, the PLL can be completely disabled in order to minimize power dissipation.

The software-programmable PLL is controlled using the 16-bit memory-mapped (address 0058h) clock mode register (CLKMD). The CLKMD register is used to define the clock configuration of the PLL clock module. Upon reset, the CLKMD register is initialized with a predetermined value dependent only upon the state of the CLKMD1 – CLKMD3 pins as shown in Table 9.

CLKMD1	CLKMD2	CLKMD3	CLKMD RESET VALUE	CLOCK MODE
0	0	0	E007h	PLL x 15
0	0	1	9007h	PLL x 10
0	1	0	4007h	PLL x 5
1	0	0	1007h	PLL x 2
1	1	0	F007h	PLL x 1
1	1	1	0000h	1/2 (PLL disabled)
1	0	1	F000h	1/4 (PLL disabled)
0	1	1	_	Reserved

#### Table 9. Clock Mode Settings at Reset



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### DMA controller

The '5409 direct memory access (DMA) controller transfers data between points in the memory map without intervention by the CPU. The DMA controller allows movements of data to and from internal program/data memory, internal peripherals (such as the McBSPs), and external program/data memory to occur in the background of CPU operation. The DMA has six independent programmable channels allowing six different contexts for DMA operation.

### features

The DMA has the following features:

- The DMA has external memory access.
- The DMA operates independently of the CPU.
- The DMA has six channels. The DMA can keep track of the contexts of six independent block transfers.
- The DMA has higher priority than the CPU for internal accesses.
- Each channel has independently programmable priorities.
- Each channel's source and destination address registers can have configurable indexes through memory on each read and write transfer, respectively. The address may remain constant, be post-incremented, post-decremented, or be adjusted by a programmable value.
- Each internal read or write transfer may be initialized by selected sync events.
- Each DMA channel is capable of sending interrupts to the CPU.
- The DMA can perform double-word transfers (a 32-bit transfer of two 16-bit words). (Internally only)

### DMA external access

The '5409 DMA supports external accesses to extended program, extended data, and extended I/O memory. These overlay pages are only visible to the DMA controller. A maximum of two DMA channels can be used for external memory accesses. The DMA external accesses require 9 cycle minimums for external writes and 13 cycle minimums for external reads.

The control of the bus is arbitrated between the CPU and the DMA. While the DMA or CPU is in control of the external bus the other will be held-off via wait states until the current transfer is complete. The DMA takes precedence over XIO requests. The HOLD/HOLDA feature of the '5409 affects external CPU transfers as well as external DMA transfers. When an external processor asserts the HOLD pin to gain control of the memory interface, the HOLDA signal is not asserted until all pending DMA transfers are complete. To prevent the DMA from blocking out the CPU or HOLD/HOLDA feature from accessing the external bus, uninterrupted burst transfers are *not* supported by the DMA. Subsequently, CPU and DMA arbitration testing is performed for each external bus cycle, regardless of the bus activity.

- Only two channels are available for external accesses. (One for external reads/one for external writes.)
- Single-word (16-bit) transfers are supported for external accesses.
- The DMA does not support transfers from peripherals to external memory.
- The DMA does not support transfers from external memory to the peripherals.
- The DMA does not support external to external transfers.
- The DMA does not support synchronized external transfers.

The HM bit in the ST1 register indicates whether the processor continues internal execution when acknowledging an active HOLD signal.

- HM = 0, the processor continues execution from internal program memory but places its external interface in the high impedance state.
- HM = 1, the processor halts internal execution.

To ensure that proper arbitration occurs, the HM bit should be set to 0 in the memory-mapped ST1 register. If the HM is set to 1 the processor will halt during DMA external transfers.



### DMA external transfer

Unlike the '5410, the '5409 DMA mode control register (DMMCRx) has two additional bits; DLAXS (DMMCRn[5]) and SLAXS (DMMCRn[11]). These new bits specify the on/off-chip memory for the source and destination of the program/data/IO spaces.

- When DLAXS is set to 0 (default), the DMA does not perform an external access for the destination. When DLAXS is set to 1, the DMA performs an external access to the destination location.
- When SLAXS is set to 0 (default), the DMA does not perform an external access for the source. When DLAXS is set to 1, the DMA performs an external access from the source location.

Two new registers are added to the '5409 DMA to support DMA accesses to/from DMA extended data memory, page 1 to page 127.

- The DMA extended source data page register (XSRCDP[6:0]) is located at subbank address 028h.
- The DMA extended destination data page register (XDSTDP[6:0]) is located at subbank address 029h.



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## DMA memory map

The DMA memory map, as shown in Figure 9, allows DMA transfers to be unaffected by the status of the MP/MC, DROM, and OVLY bits.

Hex	Program	Hex	Program	Hex	Program	Hov	Data	Hex	Data	Hex	I/O
Hex 0000 007F 0080 7FFF 8000	Reserved DARAM Internal 32K	Hex 010000	External	Hex xx0000	External	Hex 0000 001F 0022 0023 0024 0027 0030 0031 0032 0033 0034 0035 0036 0037 0038 0039 003A 0039 003A 0039 003A 0039 003A 0039 003A 0039 003A 0038 0037 0038 0039 003A	Reserved DRR20 DRR10 DXR20 DXR10 Reserved DRR22 DRR12 DXR22 DXR12 Reserved RCERA2 XCERA2 XCERA2 Reserved RCERA0 XCERA0 XCERA0 Reserved DRR21 DRR11 DXR21 DXR11 Reserved RCERA1 XCERA1 XCERA1	Hex xx0000	External	Hex 0000	External
BFFF			External			004C	Reserved				
C000						005F 0060 007F 0080	Scratch- Pad RAM DARAM				
						7FFF					
						8000	External				
FFFF		01FFFF		xxFFFF		FFFF		xxFFFF		FFFF	
	Page 0		Page n		Page 5, 6, .			Page	1, 2, 127	Page	e 0, 1, 127
NOTE: n =	= 1, 2, 3, or 4										

Figure 9. 320VC5409 DMA Memory Map

## DMA priority level

Each DMA channel can be independently assigned high priority or low priority relative to each other. Multiple DMA channels that are assigned to the same priority level are handled in a round-robin manner.



### DMA source/destination address modification

The DMA provides flexible address-indexing modes for easy implementation of data management schemes such as autobuffering and circular buffers. Source and destination addresses can be indexed separately and can be post-incremented, post-decremented, or post-incremented with a specified index offset.

#### DMA in autoinitialization mode

The DMA can automatically reinitialize itself after completion of a block transfer. Some of the DMA registers can be preloaded for the next block transfer through the DMA global reload registers (DMGSA, DMGDA, and DMGCR). Autoinitialization allows:

- Continuous operation: Normally, the CPU would have to reinitialize the DMA immediately after the completion of the current block transfer; but with the global reload registers, it can reinitialize these values for the next block transfer any time after the current block transfer begins.
- Repetitive operation: The CPU does not preload the global reload register with new values for each block transfer but only loads them on the first block transfer.

#### DMA transfer counting

The DMA channel element count register (DMCTRx) and the frame count register (DMFRCx) contain bit fields that represent the number of frames and the number of elements per frame to be transferred.

- Frame count. This 8-bit value defines the total number of frames in the block transfer. The maximum number of frames per block transfer is 128 (FRAME COUNT= 0ffh). The counter is decremented upon the last read transfer in a frame transfer. Once the last frame is transferred, the selected 8-bit counter is reloaded with the DMA global frame reload register (DMGFR) if the AUTOINIT bit is set to 1. A frame count of 0 (default value) means the block transfer contains a single frame.
- Element count. This 16-bit value defines the number of elements per frame. This counter is decremented after the read transfer of each element. The maximum number of elements per frame is 65536 (DMCTRn = 0FFFFh). In autoinitialization mode, once the last frame is transferred, the counter is reloaded with the DMA global count reload register (DMGCR).

#### DMA transfers in double-word mode (Internal Only)

Double-word mode allows the DMA to transfer 32-bit words in any index mode. In double-word mode, two consecutive 16-bit transfers are initiated and the source and destination addresses are automatically updated following each transfer. In this mode, each 32-bit word is considered to be one element.

#### DMA channel index registers

The particular DMA channel index register is selected by way of the SIND and DIND field in the DMA mode control register (DMMCRx). Unlike basic address adjustment, in conjunction with the frame index DMFRI0 and DMFRI1, the DMA allows different adjustment amounts depending on whether or not the element transfer is the last in the current frame. The normal adjustment value (element index) is contained in the element index registers DMIDX0 and DMIDX1. The adjustment value (frame index) for the end of the frame is determined by the selected DMA frame index register (either DMFRI0 or DMFRI1).

The element index and the frame index affect address adjustment as follows:

- Element index: For all except the last transfer in the frame, the element index determines the amount to be added to the DMA channel for the source/destination address register (DMSRCx/DMDSTx) as selected by the SIND/DIND bits.
- Frame index: If the transfer is the last in a frame, the frame index is used for address adjustment as selected by the SIND/DIND bits. This occurs in both single-frame and multi-frame transfer.



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### DMA interrupts

The ability of the DMA to interrupt the CPU based on the status of the data transfer is configurable and is determined by the IMOD and DINM bits in the DMA channel mode control register (DMMCRn). The available modes are shown in Table 10.

MODE	DINM	IMOD	INTERRUPT	
ABU (non-decrement)	1	0	At full buffer only	
ABU (non-decrement)	1	1	At half buffer and full buffer	
Multi-Frame	1	0	At block-transfer complete (DMCTRn = DMSEFCn[7:0] = 0)	
Multi-Frame	1	1	At end of frame and end of block (DMCTRn = 0)	
Either	0	Х	No interrupt generated	
Either	0	Х	No interrupt generated	

#### Table 10. DMA Interrupts

### DMA controller synchronization events

The internal transfers associated with each DMA channel can be synchronized to one of several events. The DSYN bit field of the DMSEFCn register selects the synchronization event for a channel. The list of possible events and the DSYN values are shown in Table 11.

DSYN VALUE	DMA SYNCHRONIZATION EVENT
0000b	No synchronization used
0001b	McBSP0 receive event
0010b	McBSP0 transmit event
0011b	McBSP2 receive event
0100b	McBSP2 transmit event
0101b	McBSP1 receive event
0110b	McBSP1 transmit event
0111b	Reserved
1000b	Reserved
1001b	Reserved
1010b	Reserved
1011b	Reserved
1100b	Reserved
1101b	Timer interrupt event
1110b	External interrupt 3
1111b	Reserved

## Table 11. DMA Synchronization Events



## DMA channel interrupt selection

The DMA controller can generate a CPU interrupt for each of the six channels. However, due to a limit on the number of internal CPU interrupt inputs, channels 0, 1, 2, and 3 are multiplexed with other interrupt sources. DMA channels 0, 1, 2, and 3 share an interrupt line with the receive and transmit portions of the McBSP. When the '5409 is reset, the interrupts from these three DMA channels are deselected. The INTSEL bit field in the DMPREC register can be used to select these interrupts, as shown in Table 12.

INTSEL Value	IMR/IFR[6]	IMR/IFR[7]	IMR/IFR[10]	IMR/IFR[11]		
00b (reset)	BRINT2	BXINT2	BRINT1	BXINT1		
01b	BRINT2	BXINT2	DMAC2	DMAC3		
10b	DMAC0	DMAC1	DMAC2	DMAC3		
11b	Reserved					

### Table 12. DMA Channel Interrupt Selection

## memory-mapped registers

The '5409 has 27 memory-mapped CPU registers, which are mapped in data memory space addresses 0h to 1Fh. The device also has a set of memory-mapped registers associated with peripherals. Table 13 gives a list of CPU memory-mapped registers (MMRs) available on '5409. Table 14 shows additional peripheral MMRs associated with the '5409.



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## memory-mapped registers (continued)

	ADD	RESS	DECODIDITION		
NAME	DEC	HEX	DESCRIPTION		
IMR	0	0	Interrupt mask register		
IFR	1	1	Interrupt flag register		
-	2–5	2–5	Reserved for testing		
ST0	6	6	Status register 0		
ST1	7	7	Status register 1		
AL	8	8	Accumulator A low word (15–0)		
AH	9	9	Accumulator A high word (31–16)		
AG	10	А	Accumulator A guard bits (39-32)		
BL	11	В	Accumulator B low word (15–0)		
BH	12	С	Accumulator B high word (31–16)		
BG	13	D	Accumulator B guard bits (39-32)		
TREG	14	E	Temporary register		
TRN	15	F	Transition register		
AR0	16	10	Auxiliary register 0		
AR1	17	11	Auxiliary register 1		
AR2	18	12	Auxiliary register 2		
AR3	19	13	Auxiliary register 3		
AR4	20	14	Auxiliary register 4		
AR5	21	15	Auxiliary register 5		
AR6	22	16	Auxiliary register 6		
AR7	23	17	Auxiliary register 7		
SP	24	18	Stack pointer register		
BK	25	19	Circular buffer size register		
BRC	26	1A	Block repeat counter		
RSA	27	1B	Block repeat start address		
REA	28	1C	Block repeat end address		
PMST	29	1D	Processor mode status (PMST) register		
XPC	30	1E	Extended program page register		
-	31	1F	Reserved		



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# memory-mapped registers (continued)

NAME	ADDRESS	DESCRIPTION	TYPE
DRR20	20h	Data receive register 2	McBSP #0
DRR10	21h	Data receive register 1	McBSP #0
DXR20	22h	Data transmit register 2	McBSP #0
DXR10	23h	Data transmit register 1	McBSP #0
TIM	24h	Timer register	Timer
PRD	25h	Timer period counter	Timer
TCR	26h	Timer control register	Timer
-	27h	Reserved	
SWWSR	28h	Software wait-state register	External Bus
BSCR	29h	Bank-switching control register	External Bus
_	2Ah	Reserved	
SWCR	2Bh	Software wait-state control register	External Bus
HPIC	2Ch	HPI control register	HPI
_	2Dh-2Fh	Reserved	
DRR22	30h	Data receive register 2	McBSP #2
DRR12	31h	Data receive register 1	McBSP #2
DXR22	32h	Data transmit register 2	McBSP #2
DXR12	33h	Data transmit register 2	McBSP #2
SPSA2	34h	McBSP2 subbank address register	McBSP #2
SPSD2	35h	McBSP2 subbank data register	McBSP #2
-	36–37h	Reserved	
SPSA0	38h	McBSP0 subbank address register	McBSP #0
SPCD0	39h	McBSP0 subbank data register	McBSP #0
-	3Ah–3Bh	Reserved	
GPIOCR	3C	General-purpose I/O pins control register	GPIO
GPIOSR	3D	General-purpose I/O pins status register	GPIO
-	3E-3F	Reserved	
DRR21	40h	Data receive register 1	McBSP #1
DRR11	41h	Data receive register 2	McBSP #1
DXR21	42h	Data transmit register 1	McBSP #1
DXR11	43h	Data transmit register 2	McBSP #1
_	44h-47h	Reserved	
SPSA1	48h	McBSP1 subbank address register	McBSP #1
SPCD1	49h	McBSP1 subbank data register	McBSP #1
-	4Ah-53h	Reserved	
DMPREC	54h	DMA channel priority and enable control register	DMA
DMSA	55h	DMA subbank address register	DMA
DMSDI	56h	DMA subbank data register with autoincrement	DMA
DMSDN	57h	DMA subbank data register	DMA
CLKMD	58h	Clock mode register	PLL
	59h-5Fh	Reserved	

## Table 14. Peripheral Memory-Mapped Registers



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#### McBSP control registers and subaddresses

The control registers for the multichannel buffered serial port (McBSP) are accessed using the subbank addressing scheme. This allows a set or subbank of registers to be accessed through a single memory location. The serial port subbank address (SPSA) register is used as a pointer to select a particular register within the subbank. The serial port subbank data (SPSD) register is used to access (read or write) the selected register. Table 15 shows the McBSP control registers and their corresponding subaddresses.

МсВ	McBSP0		SP1	McBSP2		SUB	
NAME	ADDRESS	NAME	ADDRESS	NAME	ADDRESS	ADDRESS	DESCRIPTION
SPCR10	39h	SPCR11	49h	SPCR12	35h	00h	Serial port control register 1
SPCR20	39h	SPCR21	49h	SPCR22	35h	01h	Serial port control register 2
RCR10	39h	RCR11	49h	RCR12	35h	02h	Receive control register 1
RCR20	39h	RCR21	49h	RCR22	35h	03h	Receive control register 2
XCR10	39h	XCR11	49h	XCR12	35h	04h	Transmit control register 1
XCR20	39h	XCR21	49h	XCR22	35h	05h	Transmit control register 2
SRGR10	39h	SRGR11	49h	SRGR12	35h	06h	Sample rate generator register 1
SRGR20	39h	SRGR21	49h	SRGR22	35h	07h	Sample rate generator register 2
MCR10	39h	MCR11	49h	MCR12	35h	08h	Multichannel register 1
MCR20	39h	MCR21	49h	MCR22	35h	09h	Multichannel register 2
RCERA0	39h	RCERA1	49h	RCERA2	35h	0Ah	Receive channel enable register partition A
RCERB0	39h	RCERB1	49h	RCERB2	35h	0Bh	Receive channel enable register partition B
XCERA0	39h	XCERA1	49h	XCERA2	35h	0Ch	Transmit channel enable register partition A
XCERB0	39h	XCERB1	49h	XCERB2	35h	0Dh	Transmit channel enable register partition B
PCR0	39h	PCR1	49h	PCR2	35h	0Eh	Pin control register

#### Table 15. McBSP Control Registers and Subaddresses

### DMA subbank addressed registers

The direct memory access (DMA) controller has several control registers associated with it. The main control register (DMPREC) is a standard memory mapped register. However, the other registers are accessed using the subbank addressing scheme. This allows a set, or subbank of registers to be accessed through a single memory location. The DMA subbank address (DMSA) register is used as a pointer to select a particular register within the subbank, while the DMA subbank data (DMSDN) register or the DMA subbank data register with autoincrement (DMSDI) is used to access (read or write) the selected register.

When the DMSDI register is used to access the subbank, the subbank address is automatically postincremented so that a subsequent access affects the next register within the subbank. This autoincrement feature is intended for efficient, successive accesses to several control registers. If the auto-increment feature is not required, the DMSDN register should be used to access the subbank. Table 16 shows the DMA controller subbank addressed registers and their corresponding subaddresses.



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## DMA subbank addressed registers (continued)

Table 16	. DMA	Subbank	Addressed	Registers
----------	-------	---------	-----------	-----------

DMA		SUB					
NAME	ADDRESS	ADDRESS	DESCRIPTION				
DMSRC0	56h/57h	00h	DMA channel 0 source address register				
DMDST0	56h/57h	01h	DMA channel 0 destination address register				
DMCTR0	56h/57h	02h	DMA channel 0 element count register				
DMSFC0	56h/57h	03h	DMA channel 0 sync select and frame count register				
DMMCR0	56h/57h	04h	DMA channel 0 transfer mode control register				
DMSRC1	56h/57h	05h	DMA channel 1 source address register				
DMDST1	56h/57h	06h	DMA channel 1 destination address register				
DMCTR1	56h/57h	07h	DMA channel 1 element count register				
DMSFC1	56h/57h	08h	DMA channel 1 sync select and frame count register				
DMMCR1	56h/57h	09h	DMA channel 1 transfer mode control register				
DMSRC2	56h/57h	0Ah	DMA channel 2 source address register				
DMDST2	56h/57h	0Bh	DMA channel 2 destination address register				
DMCTR2	56h/57h	0Ch	DMA channel 2 element count register				
DMSFC2	56h/57h	0Dh	DMA channel 2 sync select and frame count register				
DMMCR2	56h/57h	0Eh	DMA channel 2 transfer mode control register				
DMSRC3	56h/57h	0Fh	DMA channel 3 source address register				
DMDST3	56h/57h	10h	DMA channel 3 destination address register				
DMCTR3	56h/57h	11h	DMA channel 3 element count register				
DMSFC3	56h/57h	12h	DMA channel 3 sync select and frame count register				
DMMCR3	56h/57h	13h	DMA channel 3 transfer mode control register				
DMSRC4	56h/57h	14h	DMA channel 4 source address register				
DMDST4	56h/57h	15h	DMA channel 4 destination address register				
DMCTR4	56h/57h	16h	DMA channel 4 element count register				
DMSFC4	56h/57h	17h	DMA channel 4 sync select and frame count register				
DMMCR4	56h/57h	18h	DMA channel 4 transfer mode control register				
DMSRC5	56h/57h	19h	DMA channel 5 source address register				
DMDST5	56h/57h	1Ah	DMA channel 5 destination address register				
DMCTR5	56h/57h	1Bh	DMA channel 5 element count register				
DMSFC5	56h/57h	1Ch	DMA channel 5 sync select and frame count register				
DMMCR5	56h/57h	1Dh	DMA channel 5 transfer mode control register				
DMSRCP	56h/57h	1Eh	DMA source program page address (common channel)				
DMDSTP	56h/57h	1Fh	DMA destination program page address (common channel)				
DMIDX0	56h/57h	20h	DMA element index address register 0				
DMIDX1	56h/57h	21h	DMA element index address register 1				
DMFRI0	56h/57h	22h	DMA frame index register 0				
DMFRI1	56h/57h	23h	DMA frame index register 1				
DMGSA	56h/57h	24h	DMA global source address reload register				
DMGDA	56h/57h	25h	DMA global destination address reload register				
DMGCR	56h/57h	26h	DMA global count reload register				
DMGFR	56h/57h	27h	DMA global frame count reload register				
XSRCDP	56h/57h	28h	DMA global extended source register				
XDSTDP	56h/57h	29h	DMA global extended destination register				



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## interrupts

Vector-relative locations and priorities for all internal and external interrupts are shown in Table 17.

NAME	LOCA DECIMAL	TION HEX	PRIORITY	FUNCTION				
RS, SINTR	0	0 00		Reset (hardware and software reset)				
NMI, SINT16	4	04	2	Nonmaskable interrupt				
SINT17	8	08		Software interrupt #17				
SINT18	12	0C		Software interrupt #18				
SINT19	16	10	—	Software interrupt #19				
SINT20	20	14		Software interrupt #20				
SINT21	24	18	—	Software interrupt #21				
SINT22	28	1C	—	Software interrupt #22				
SINT23	32	20	—	Software interrupt #23				
SINT24	36	24	—	Software interrupt #24				
SINT25	40	28		Software interrupt #25				
SINT26	44	2C	—	Software interrupt #26				
SINT27	48	30	—	Software interrupt #27				
SINT28	52	34	—	Software interrupt #28				
SINT29	56	38	—	Software interrupt #29				
SINT30	60	3C	—	Software interrupt #30				
ĪNTO, SINTO	64	40	3	External user interrupt #0				
INT1, SINT1	68	44	4	External user interrupt #1				
INT2, SINT2	72	48	5	External user interrupt #2				
TINT, SINT3	76	4C	6	Timer interrupt				
BRINTO, SINT4	80	50	7	McBSP #0 receive interrupt (default)				
BXINTO, SINT5	84	54	8	McBSP #0 transmit interrupt (default)				
BRINT2, SINT7, DMAC0	88	58	9	McBSP #2 receive interrupt (default)				
BXINT2, SINT6, DMAC1	92	5C	10	McBSP #2 transmit interrupt (default)				
ĪNT3, SINT8	96	60	11	External user interrupt #3				
HINT, SINT9	100	64	12	HPI interrupt				
BRINT1, SINT10, DMAC2	104	68	13	McBSP #1 receive interrupt (default)				
BXINT1, SINT11, DMAC3	108	6C	14	McBSP #1 transmit interrupt (default)				
DMAC4,SINT12	112	70	15	DMA channel 4 interrupt (default)				
DMAC5,SINT13	116	74	16	DMA channel 5 interrupt (default)				
Reserved	120–127	78–7F	_	Reserved				

## Table 17. Interrupt Locations and Priorities



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## interrupts (continued)

The bits of the interrupt flag register (IFR) and interrupt mask register (IMR) are arranged as shown in Figure 10. The function of each bit is described in Table 18.

15–14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
RES	DMAC5	DMAC4	BXINT1 DMAC3	BRINT1 DMAC2	HINT	INT3	BXINT2 DMAC1	BRINT2 DMAC0	BXINTO	BRINTO	TINT	INT2	INT1	INTO

### Figure 10. IFR and IMR Registers

### Table 18. IFR and IMR Register Bit Fields

BIT						
NUMBER	NAME	FUNCTION				
15–14	-	Reserved for future expansion				
13	DMAC5	DMA channel 5 interrupt flag/mask bit				
12	DMAC4	DMA channel 4 interrupt flag/mask bit				
11	BXINT1/DMAC3	McBSP1 transmit interrupt flag/mask bit				
10	BRINT1/DMAC2	McBSP1 receive interrupt flag/mask bit				
9	HINT	Host to '54x interrupt flag/mask				
8	INT3	External interrupt 3 flag/mask				
7	BXINT2/DMAC1	McBSP2 transmit interrupt flag/mask bit				
6	BRINT2/DMAC0	McBSP2 receive interrupt flag/mask bit				
5	BXINT0	McBSP0 transmit interrupt flag/mask bit				
4	BRINT0	McBSP0 receive interrupt flag/mask bit				
3	TINT	Timer interrupt flag/mask bit				
2	INT2	External interrupt 2 flag/mask bit				
1	INT1	External interrupt 1 flag/mask bit				
0	INTO	External interrupt 0 flag/mask bit				

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### documentation support

Extensive documentation supports all TMS320 family generations of devices from product announcement through applications development. The following types of documentation are available to support the design and use of the 'C5000 family of DSPs:

- TMS320C5000 DSP Family Functional Overview (literature number SPRU307)
- Device-specific data sheets (such as this document)
- Complete User Guides
- Development-support tools
- Hardware and software application reports

The five-volume TMS320C54x DSP Reference Set (literature number SPRU210) consists of:

- Volume 1: CPU and Peripherals (literature number SPRU131)
- Volume 2: Mnemonic Instruction Set (literature number SPRU172)
- Volume 3: Algebraic Instruction Set (literature number SPRU179)
- Volume 4: Applications Guide (literature number SPRU173)
- Volume 5: Enhanced Peripherals (literature number SPRU302)

The reference set describes in detail the TMS320C54x products currently available, and the hardware and software applications, including algorithms, for fixed-point TMS320 devices.

For general background information on DSPs and Texas Instruments (TI<sup>™</sup>) devices, see the three-volume publication *Digital Signal Processing Applications with the TMS320 Family* (literature numbers SPRA012, SPRA016, and SPRA017).

A series of DSP textbooks is published by Prentice-Hall and John Wiley & Sons to support digital signal processing research and education. The TMS320 newsletter, *Details on Signal Processing*, is published quarterly and distributed to update TMS320 customers on product information.

Information regarding TI DSP products is also available on the Worldwide Web at *http://www.ti.com* uniform resource locator (URL).

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absolute maximum ratings ov	er specified tempe	erature range (unless	s otherwise noted) <sup>†‡</sup>

Supply voltage I/O range, DV <sub>DD</sub> §	–0.3 V to 4.0 V
Supply voltage core range, CV <sub>DD</sub> <sup>§</sup>	–0.3 V to 2.4 V
Input voltage range, V <sub>I</sub>	–0.3 V to 4.5 V
Output voltage range, V <sub>O</sub>	–0.3 V to 4.5 V
Operating case temperature range, T <sub>C</sub>	–40°C to 100°C
Storage temperature range, T <sub>stg</sub>	–55°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>‡</sup> Long term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life. See www.ti.com/ep\_quality for additional information on enhanced plastic packaging.

§ All voltage values are with respect to V<sub>SS</sub>.

#### recommended operating conditions

			MIN	NOM	MAX	UNIT
DV <sub>DD</sub>	Device supply voltage, I/O§		3	3.3	3.6	V
CV <sub>DD</sub>	Device supply voltage, core§		1.71	1.8	1.98	V
V <sub>SS</sub>	Supply voltage, GND			0		V
		$eq:rescaled_$	2.2		DV <sub>DD</sub> + 0.3	
VIH	High-level input voltage, I/O	TRST	2.5		DV <sub>DD</sub> + 0.3	V
		X2/CLKIN	1.4		CV <sub>DD</sub> + 0.3	
		All other inputs	2.0		DV <sub>DD</sub> + 0.3	
V <sub>IL</sub>	Low-level input voltage	RS, INTn, NMI, X2/CLKIN, BIO, BCLKR0, BCLKR1, BCLKR2, BCLKX0, BCLKX1, BCLKX2, HAS, HCS, HDS1, HDS2, TCK, CLKMDn, DV <sub>DD</sub> = 3.3 ± 0.3 V	-0.3		0.6	V
	All other inputs	-0.3		0.8		
I <sub>OH</sub>	High-level output current	•			-300	μA
I <sub>OL</sub>	Low-level output current				1.5	mA
Т <sub>С</sub>	Operating case temperature		-40		100	°C

<sup>§</sup> Texas Instrument DSPs do not require specific power sequencing between the core supply and the I/O supply. However, systems should be designed to ensure that neither supply is powered up for extended periods of time if the other supply is below the proper operating voltage. Excessive exposure to these conditions can adversely affect the long-term reliability of the devices. System-level concerns such as bus contention may require supply sequencing to be implemented. In this case, the core supply should be powered up at the same time as or prior to the I/O buffers, and then powered down after the I/O buffers.



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# electrical characteristics over recommended operating case temperature range (unless otherwise noted)

	PARAME	TER	TEST CONDIT	IONS	MIN	TYP <sup>†</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output vol	tage	I <sub>OH</sub> = MAX		2.4			V
V <sub>OL</sub>	Low-level output volt	tage	I <sub>OL</sub> = MAX				0.4	V
I <sub>IZ</sub>	Input current for outputs in high	D[15:0], HD[7:0], A[15:0]	Bus holders enabled, $DV_{DD}$ $V_{I} = V_{SS}$ to $DV_{DD}$	= MAX,	-200		200	μA
	impedance		DV <sub>DD</sub>	-5		5		
		X2/CLKIN			-40	-40 40		
		TRST	With internal pulldown		-5		200	
l,	Input current			-5		200	μA	
"		TMS, TCK, TDI, HPI <sup>‡</sup>	With internal pullups, HPIENA = 0	to DV <sub>DD</sub> )	-200		5	pre s
		All other input-only pins		-5		5		
IDDC	Supply current, core	CPU	$CV_{DD}$ = 1.8 V, $f_{clock}$ = 100 N	lHz, <sup>§</sup> T <sub>C</sub> = 25°C <sup>¶</sup>		37		mA
I <sub>DDP</sub>	Supply current, pins		DV <sub>DD</sub> = 3.3 V, f <sub>clock</sub> = 100 N	1Hz, <sup>§</sup> T <sub>C</sub> = 25°C <sup>#</sup>		45		mA
	Supply current,	IDLE2	$PLL \times 2$ mode, 50 MHz inp	out		2		mA
I <sub>DD</sub>	standby	IDLE3	Divide-by-two mode, CLKIN	stopped		20		μA
Ci	Input capacitance					5		pF
Co	Output capacitance					5		pF

<sup>†</sup> All values are typical unless otherwise specified.

<sup>‡</sup> HPI input signals except for HPIENA.

§ Clock mode: PLL × 1 with external source

<sup>¶</sup> This value represents the current consumption of the CPU, on-chip memory, and on-chip peripherals. Conditions include: program execution from on-chip RAM, with 50% usage of MAC and 50% usage of NOP instructions. Actual operating current varies with program being executed.

<sup>#</sup> This value was obtained using the following conditions: external memory writes at a rate of 20 million writes per second, CLKOFF=0, full-duplex operation of all three McBSPs at a rate of 10 million bits per second each, and 15-pF loads on all outputs. For more details on how this calculation is performed, refer to the *Calculation of TMS320C54x Power Dissipation Application Report* (literature number SPRA164).

## PARAMETER MEASUREMENT INFORMATION

The following load circuit in Figure 11 was used on all outputs pins and I/O pins in input mode. All timing measurements in this data sheet were measured from the '5409 connection to the following load circuit.

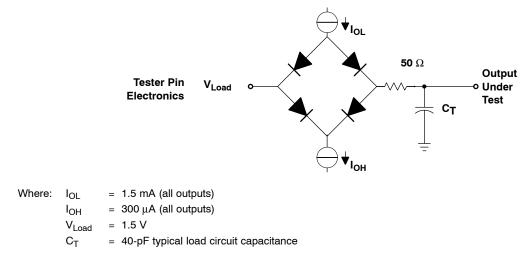


Figure 11. 3.3-V Test Load Circuit



#### internal oscillator with external crystal

The internal oscillator is enabled by connecting a crystal across X1 and X2/CLKIN. The frequency of CLKOUT is a multiple of the oscillator frequency. The multiply ratio is determined by the bit settings in the CLKMD register. The crystal should be in fundamental-mode operation, and parallel resonant, with an effective series resistance of 30  $\Omega$  and power dissipation of 1 mW.

The connection of the required circuit, consisting of the crystal and two load capacitors, is shown in Figure 12. The load capacitors,  $C_1$  and  $C_2$ , should be chosen such that the equation below is satisfied.  $C_L$  in the equation is the load specified for the crystal.

$$C_{L} = \frac{C_{1}C_{2}}{(C_{1} + C_{2})}$$

#### recommended operating conditions of internal oscillator with external crystal (see Figure 12)

		MIN	NOM	MAX	UNIT
f <sub>clock</sub>	Input clock frequency	10		20	MHz

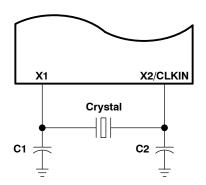


Figure 12. Internal Oscillator With External Crystal



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#### divide-by-two/divide-by-four clock option (PLL disabled)

The frequency of the reference clock provided at the X2/CLKIN pin can be divided by a factor of two or four to generate the internal machine cycle. The selection of the clock mode is described in the clock generator section.

When an external clock source is used, the frequency injected must conform to specifications listed in the timing requirements table.

## switching characteristics over recommended operating conditions $[H = 0.5t_{c(CO)}]^{\dagger}$ (see Figure 12, Figure 13, and the recommended operating conditions table)

	PARAMETER	MIN	ТҮР	MAX	UNIT
t <sub>c(CO)</sub>	Cycle time, CLKOUT	40	2t <sub>c(CI)</sub>	†	ns
t <sub>d(CIH-CO)</sub>	Delay time, X2/CLKIN high to CLKOUT high/low	4	10	17	ns
t <sub>f(CO)</sub>	Fall time, CLKOUT		2		ns
t <sub>r(CO)</sub>	Rise time, CLKOUT		2		ns
t <sub>w(COL)</sub>	Pulse duration, CLKOUT low	H–2	H–1	Н	ns
t <sub>w(COH)</sub>	Pulse duration, CLKOUT high	H–2	H–1	Н	ns

<sup>†</sup> This device utilizes a fully static design and therefore can operate with  $t_{c(CI)}$  approaching  $\infty$ . The device is characterized at frequencies approaching 0 Hz.

### timing requirements (see Figure 13)

		MIN	MAX	UNIT
t <sub>c(CI)</sub>	Cycle time, X2/CLKIN	20	†	ns
t <sub>f(CI)</sub>	Fall time, X2/CLKIN		8	ns
t <sub>r(CI)</sub>	Rise time, X2/CLKIN		8	ns
tw(CIL)	Pulse duration, X2/CLKIN low	5		ns
tw(CIH)	Pulse duration, X2/CLKIN high	5		ns

<sup>†</sup> This device utilizes a fully static design and therefore can operate with  $t_{c(CI)}$  approaching  $\infty$ . The device is characterized at frequencies approaching 0 Hz.

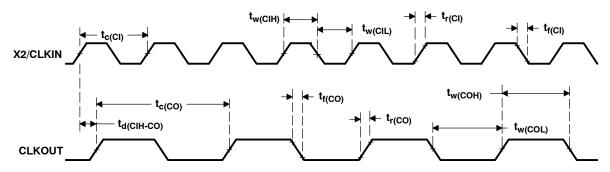


Figure 13. External Divide-by-Two Clock Timing



#### multiply-by-N clock option (PLL enabled)

The frequency of the reference clock provided at the X2/CLKIN pin can be multiplied by a factor of N to generate the internal machine cycle. The selection of the clock mode and the value of N is described in the clock generator section.

When an external clock source is used, the external frequency injected must conform to specifications listed in the timing requirements table.

## switching characteristics over recommended operating conditions [H = $0.5t_{c(CO)}$ ] (see Figure 12 and Figure 14)

	PARAMETER	MIN	TYP	MAX	UNIT
t <sub>c(CO)</sub>	Cycle time, CLKOUT	10	t <sub>c(CI)</sub> /N <sup>†</sup>		ns
t <sub>d(CI-CO)</sub>	Delay time, X2/CLKIN high/low to CLKOUT high/low	4	10	17	ns
t <sub>f(CO)</sub>	Fall time, CLKOUT		2		ns
t <sub>r(CO)</sub>	Rise time, CLKOUT		2		ns
t <sub>w(COL)</sub>	Pulse duration, CLKOUT low	H-2	H–1	Н	ns
t <sub>w(COH)</sub>	Pulse duration, CLKOUT high	H-2	H–1	Н	ns
tp	Transitory phase, PLL lock up time			30	μs

<sup>†</sup> N = Multiplication factor

#### timing requirements (see Figure 14)<sup>†</sup>

			MIN	MAX	UNIT
t <sub>c(CI)</sub>	Cycle time, X2/CLKIN	Integer PLL multiplier N (N = 1–15)	20 <sup>‡</sup>	200	
		PLL multiplier N = x.5	20 <sup>‡</sup>	100	ns
		PLL multiplier N = $x.25$ , $x.75$	20 <sup>‡</sup>	50	
t <sub>f(CI)</sub>	Fall time, X2/CLKIN			8	ns
t <sub>r(CI)</sub>	Rise time, X2/CLKIN			8	ns
tw(CIL)	Pulse duration, X2/CLKIN low		5		ns
tw(CIH)	Pulse duration, X2/CLKIN high		5		ns

 $^{\dagger}$  N = Multiplication factor

<sup>‡</sup> The multiplication factor and minimum X2/CLKIN cycle time should be chosen such that the resulting CLKOUT cycle time is within the specified range (tc(CO))

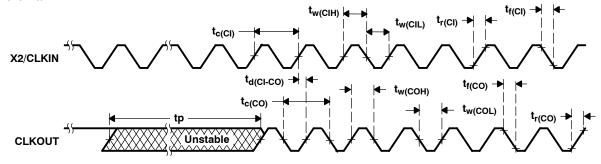


Figure 14. External Multiply-by-One Clock Timing



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#### memory and parallel I/O interface timing

# switching characteristics over recommended operating conditions for a memory read $(MSTRB = 0)^{\dagger}$ (see Figure 15)

	PARAMETER	MIN	MAX	UNIT
t <sub>d(CLKL-A)</sub>	Delay time, CLKOUT low to address valid <sup>‡</sup>	0	3	ns
t <sub>d(CLKH-A)</sub>	Delay time, CLKOUT high (transition) to address valid§	0	3	ns
t <sub>d(CLKL-MSL)</sub>	Delay time, CLKOUT low to MSTRB low	0	3	ns
t <sub>d(CLKL-MSH)</sub>	Delay time, CLKOUT low to MSTRB high	0	3	ns
t <sub>h(CLKL-A)</sub> R	Hold time, address valid after CLKOUT low <sup>‡</sup>	0	3	ns
t <sub>h(CLKH-A)</sub> R	Hold time, address valid after CLKOUT high <sup>§</sup>	0	3	ns

<sup>†</sup> Address, PS, and DS timings are all included in timings referenced as address.

<sup>‡</sup> In the case of a memory read preceded by a memory read

§ In the case of a memory read preceded by a memory write

### timing requirements for a memory read ( $\overline{\text{MSTRB}} = 0$ ) [H = 0.5 t<sub>c(CO)</sub>]<sup>†</sup> (see Figure 15)

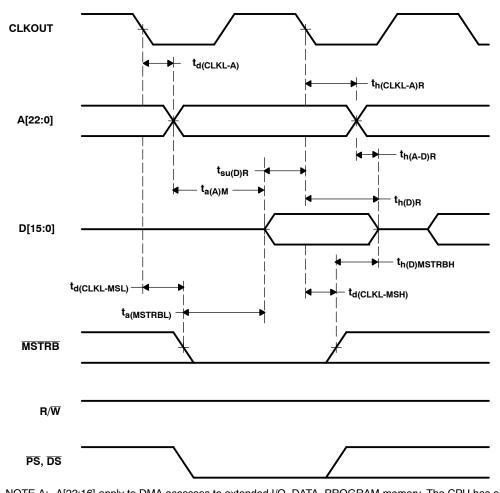
		MIN	MAX	UNIT
t <sub>a(A)M</sub>	Access time, read data access from address valid		2H-10 <sup>¶</sup>	ns
t <sub>a(MSTRBL)</sub>	Access time, read data access from MSTRB low		2H-10 <sup>¶</sup>	ns
t <sub>su(D)R</sub>	Setup time, read data before CLKOUT low	8		ns
t <sub>h(D)R</sub>	Hold time, read data after CLKOUT low	0		ns
t <sub>h(A-D)R</sub>	Hold time, read data after address invalid	0		ns
t <sub>h(D)MSTRBH</sub>	Hold time, read data after MSTRB high	1		ns

<sup>†</sup> Address, PS, and DS timings are all included in timings referenced as address.

<sup>¶</sup> This access timing reflects a zero wait-state timing.



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#### memory and parallel I/O interface timing (continued)

NOTE A: A[22:16] apply to DMA accesses to extended I/O, DATA, PROGRAM memory. The CPU has access to **only** extended PROGRAM memory.

Figure 15. Memory Read (MSTRB = 0)



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#### memory and parallel I/O interface timing (continued)

# switching characteristics over recommended operating conditions for a memory write ( $\overline{\text{MSTRB}} = 0$ ) [H = 0.5 t<sub>c(CO)</sub>]<sup>†</sup> (see Figure 16)

	PARAMETER	MIN	MAX	UNIT
t <sub>d(CLKH-A)</sub>	Delay time, CLKOUT high to address valid <sup>‡</sup>	0	3	ns
t <sub>d(CLKL-A)</sub>	Delay time, CLKOUT low to address valid§	0	3	ns
t <sub>d(CLKL-MSL)</sub>	Delay time, CLKOUT low to MSTRB low	0	3	ns
t <sub>d(CLKL-D)W</sub>	Delay time, CLKOUT low to data valid	0	8	ns
t <sub>d(CLKL-MSH)</sub>	Delay time, CLKOUT low to MSTRB high	0	3	ns
t <sub>d(CLKH-RWL)</sub>	Delay time, CLKOUT high to R/W low	0	4	ns
t <sub>d(CLKH-RWH)</sub>	Delay time, CLKOUT high to R/W high	0	4	ns
t <sub>d(RWL-MSTRBL)</sub>	Delay time, R/W low to MSTRB low	H – 2	H + 1	ns
t <sub>h(A)W</sub>	Hold time, address valid after CLKOUT high <sup>‡</sup>	0	3	ns
t <sub>h(D)MSH</sub>	Hold time, write data valid after MSTRB high	H–3	H+6 <sup>§</sup>	ns
t <sub>w(SL)MS</sub>	Pulse duration, MSTRB low	2H-2		ns
t <sub>su(A)W</sub>	Setup time, address valid before MSTRB low	2H-2		ns
t <sub>su(D)</sub> MSH	Setup time, write data valid before MSTRB high	2H-6	2H+6 <sup>§</sup>	ns
t <sub>en(D-RWL)</sub>	Enable time, data bus driven after $R/W$ low	H–5		ns
t <sub>dis(RWH-D)</sub>	Disable time, $R/\overline{W}$ high to data bus high impedance		0	ns

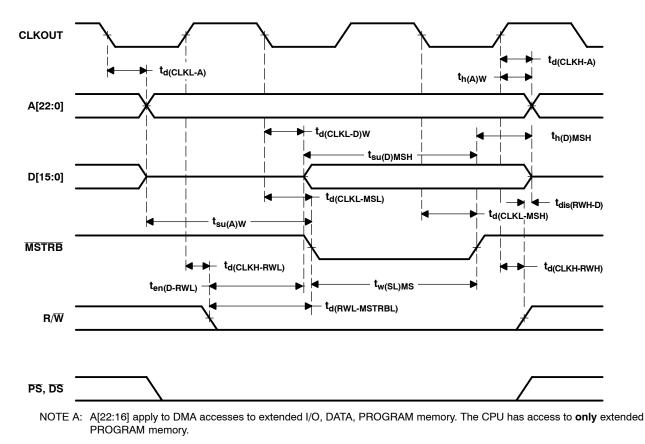
 $^{\dagger}$  Address,  $\overline{\text{PS}},$  and  $\overline{\text{DS}}$  timings are all included in timings referenced as address.

<sup>‡</sup> In the case of a memory write preceded by a memory write

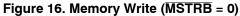
§ In the case of a memory write preceded by an I/O cycle



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### memory and parallel I/O interface timing (continued)





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#### memory and parallel I/O interface timing (continued)

# switching characteristics over recommended operating conditions for a parallel I/O port read (IOSTRB = 0)<sup>†</sup> (see Figure 17)

	PARAMETER	MIN	MAX	UNIT
t <sub>d(CLKL-A)</sub>	Delay time, CLKOUT low to address valid	0	3	ns
t <sub>d(CLKH-ISTRBL)</sub>	Delay time, CLKOUT high to IOSTRB low	0	3	ns
t <sub>d(CLKH-ISTRBH)</sub>	Delay time, CLKOUT high to IOSTRB high	0	3	ns
t <sub>h(A)IOR</sub>	Hold time, address after CLKOUT low	0	3	ns

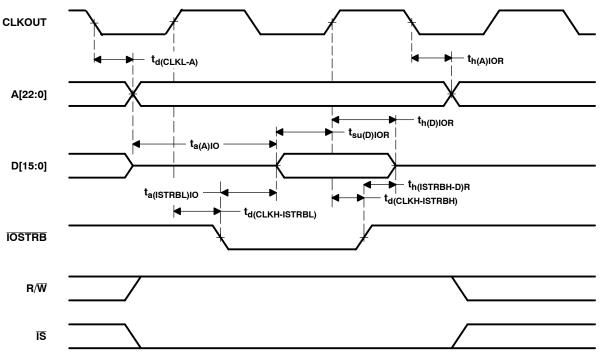
<sup>†</sup> Address and IS timings are included in timings referenced as address.

### timing requirements for a parallel I/O port read ( $\overline{IOSTRB} = 0$ ) [H = 0.5 t<sub>c(CO)</sub>]<sup>†</sup> (see Figure 17)

		MIN	MAX	UNIT
t <sub>a(A)IO</sub>	Access time, read data access from address valid <sup>‡</sup>		3H-9	ns
t <sub>a(ISTRBL)IO</sub>	Access time, read data access from IOSTRB low <sup>‡</sup>		2H-8	ns
t <sub>su(D)IOR</sub>	Setup time, read data before CLKOUT high	8		ns
t <sub>h(D)IOR</sub>	Hold time, read data after CLKOUT high	0		ns
t <sub>h(ISTRBH-D)</sub> R	Hold time, read data after IOSTRB high	0		ns

<sup>†</sup> Address and IS timings are included in timings referenced as address.

<sup>‡</sup> This access timing reflects a zero wait-state timing.







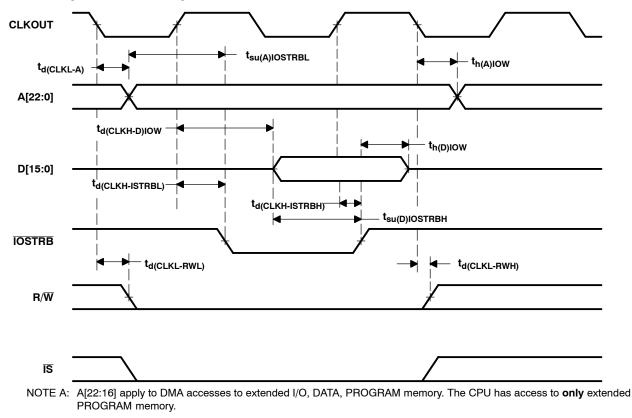
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### memory and parallel I/O interface timing (continued)

# switching characteristics over recommended operating conditions for a *parallel I/O port write* (IOSTRB = 0) [H = 0.5 t<sub>c(CO)</sub>]<sup>†</sup> (see Figure 18)

PARAMETER	MIN	MAX	UNIT
Delay time, CLKOUT low to address valid	0	3	ns
Delay time, CLKOUT high to IOSTRB low	0	3	ns
Delay time, CLKOUT high to write data valid	H–5	H+8	ns
Delay time, CLKOUT high to IOSTRB high	0	3	ns
Delay time, CLKOUT low to R/W low	0	3	ns
Delay time, CLKOUT low to R/ $\overline{W}$ high	0	3	ns
Hold time, address valid after CLKOUT low	0	3	ns
Hold time, write data after IOSTRB high	H–3	H+7	ns
Setup time, write data before IOSTRB high	H–7	H+1	ns
Setup time, address valid before IOSTRB low	H-2	H+2	ns
	Delay time, CLKOUT low to address valid         Delay time, CLKOUT high to IOSTRB low         Delay time, CLKOUT high to vrite data valid         Delay time, CLKOUT high to IOSTRB high         Delay time, CLKOUT low to R/W low         Delay time, CLKOUT low to R/W high         Hold time, address valid after CLKOUT low         Hold time, write data after IOSTRB high         Setup time, write data before IOSTRB high	Delay time, CLKOUT low to address valid0Delay time, CLKOUT high to IOSTRB low0Delay time, CLKOUT high to Vite data validH–5Delay time, CLKOUT high to IOSTRB high0Delay time, CLKOUT low to R/W low0Delay time, CLKOUT low to R/W high0Delay time, CLKOUT low to R/W high0Hold time, address valid after CLKOUT low0Hold time, write data after IOSTRB highH–3Setup time, write data before IOSTRB highH–7	Delay time, CLKOUT low to address valid03Delay time, CLKOUT high to IOSTRB low03Delay time, CLKOUT high to IOSTRB highH-5H+8Delay time, CLKOUT high to IOSTRB high03Delay time, CLKOUT low to R/W low03Delay time, CLKOUT low to R/W high03Hold time, address valid after CLKOUT low03Hold time, write data after IOSTRB highH-3H+7Setup time, write data before IOSTRB highH-7H+1

<sup>†</sup> Address and IS timings are included in timings referenced as address.



#### Figure 18. Parallel I/O Port Write (IOSTRB = 0)



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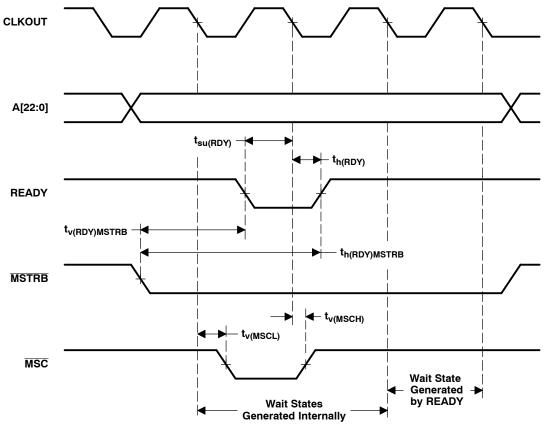
#### ready timing for externally generated wait states

# timing requirements for externally generated wait states $[H = 0.5 t_{c(CO)}]^{\dagger}$ (see Figure 19, Figure 20, Figure 21, and Figure 22)

		MIN	MAX	UNIT
t <sub>su(RDY)</sub>	Setup time, READY before CLKOUT low	7		ns
t <sub>h(RDY)</sub>	Hold time, READY after CLKOUT low	0		ns
t <sub>v(RDY)</sub> MSTRB	Valid time, READY after MSTRB low <sup>‡</sup>		4H–9	ns
t <sub>h(RDY)</sub> MSTRB	Hold time, READY after MSTRB low <sup>‡</sup>	4H		ns
t <sub>v(RDY)</sub> IOSTRB	Valid time, READY after IOSTRB low <sup>‡</sup>		5H-9	ns
t <sub>h(RDY)</sub> IOSTRB	Hold time, READY after IOSTRB low <sup>‡</sup>	5H		ns
t <sub>v(MSCL)</sub>	Valid time, MSC low after CLKOUT low	0	3	ns
t <sub>v(MSCH)</sub>	Valid time, MSC high after CLKOUT low	0	3	ns

<sup>†</sup> The hardware wait states can be used only in conjunction with the software wait states to extend the bus cycles. To generate wait states using READY, at least two software wait states must be programmed.

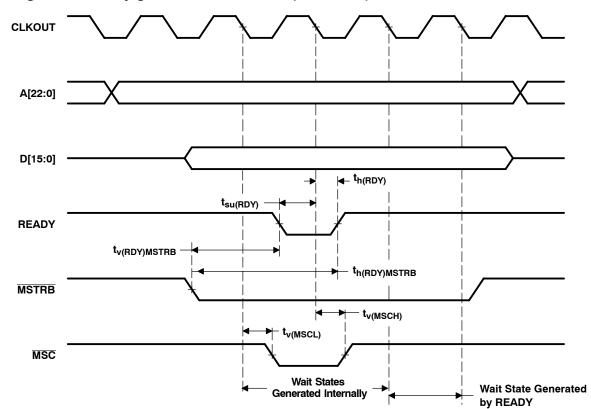
<sup>‡</sup> These timings are included for reference only. The critical timings for READY are those referenced to CLKOUT.







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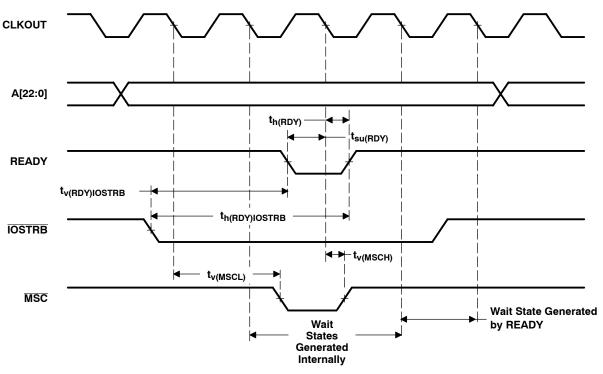
### ready timing for externally generated wait states (continued)

Figure 20. Memory Write With Externally Generated Wait States



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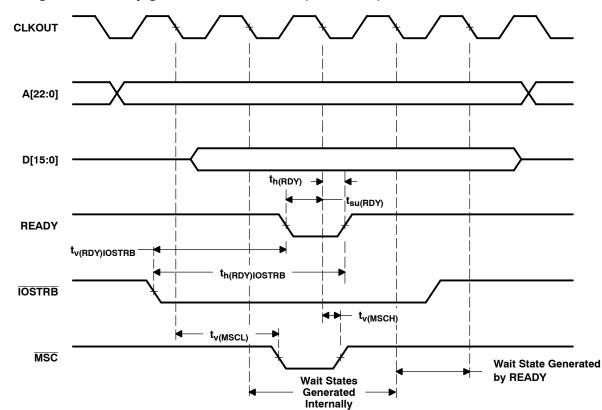
#### ready timing for externally generated wait states (continued)







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ready timing for externally generated wait states (continued)

Figure 22. I/O Write With Externally Generated Wait States



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### HOLD and HOLDA timings

# switching characteristics over recommended operating conditions for memory control signals and $\overline{\text{HOLDA}}$ , [H = 0.5 t<sub>c(CO)</sub>] (see Figure 23)

	PARAMETER	MIN	MAX	UNIT
t <sub>dis(CLKL-A)</sub>	Disable time, address, PS, DS, IS high impedance from CLKOUT low		5	ns
t <sub>dis(CLKL-RW)</sub>	Disable time, $R/\overline{W}$ high impedance from CLKOUT low		5	ns
t <sub>dis(CLKL-S)</sub>	Disable time, MSTRB, IOSTRB high impedance from CLKOUT low		5	ns
t <sub>en(CLKL-A)</sub>	Enable time, address, PS, DS, IS from CLKOUT low		2H+5	ns
t <sub>en(CLKL-RW)</sub>	Enable time, $R/\overline{W}$ enabled from CLKOUT low		2H+5	ns
t <sub>en(CLKL-S)</sub>	Enable time, MSTRB, IOSTRB enabled from CLKOUT low	1	2H+5	ns
	Valid time, HOLDA low after CLKOUT low	0	4	ns
t <sub>v(HOLDA)</sub>	Valid time, HOLDA high after CLKOUT low	0	4	ns
t <sub>w(HOLDA)</sub>	Pulse duration, HOLDA low duration	2H-1		ns

## timing requirements for memory control signals and $\overline{HOLD}$ , [H = 0.5 t<sub>c(CO)</sub>] (see Figure 23)

		MIN	MAX	UNIT
t <sub>w(HOLD)</sub>	Pulse duration, HOLD low	4H+8		ns
t <sub>su(HOLD)</sub>	Setup time, HOLD low/high before CLKOUT low	8		ns



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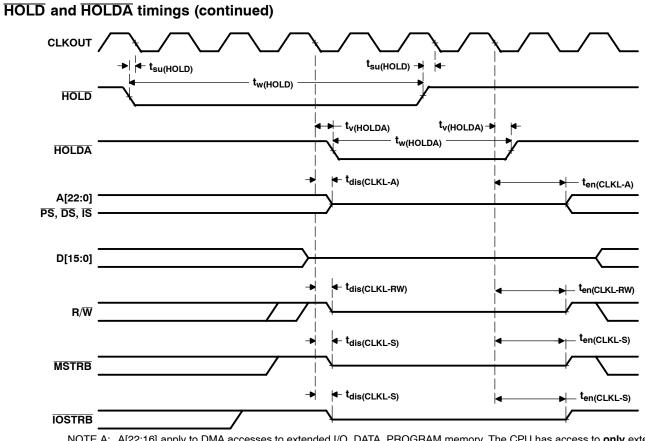




Figure 23. HOLD and HOLDA Timings (HM = 1)

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### reset, BIO, interrupt, and MP/MC timings

timing requirements for reset,  $\overline{BIO}$ , interrupt, and  $MP/\overline{MC}$  [H = 0.5 t<sub>c(CO)</sub>] (see Figure 24, Figure 25, and Figure 26)

		MIN	MAX	UNIT
t <sub>h(RS)</sub>	Hold time, RS after CLKOUT low	0		ns
t <sub>h(BIO)</sub>	Hold time, BIO after CLKOUT low	0		ns
t <sub>h(INT)</sub>	Hold time, INTn, MII, after CLKOUT low <sup>†</sup>	0		ns
t <sub>h(MPMC)</sub>	Hold time, MP/MC after CLKOUT low	0		ns
t <sub>w(RSL)</sub>	Pulse duration, RS low <sup>‡§</sup>	4H+4		ns
t <sub>w(BIO)S</sub>	Pulse duration, BIO low, synchronous	2H+1		ns
t <sub>w(BIO)A</sub>	Pulse duration, BIO low, asynchronous	4H		ns
t <sub>w(INTH)</sub> s	Pulse duration, INTn, NMI high (synchronous)	2H+1		ns
t <sub>w(INTH)A</sub>	Pulse duration, INTn, NMI high (asynchronous)	4H		ns
t <sub>w(INTL)S</sub>	Pulse duration, INTn, NMI low (synchronous)	2H+1		ns
t <sub>w(INTL)A</sub>	Pulse duration, INTn, NMI low (asynchronous)	4H		ns
t <sub>w(INTL)</sub> WKP	Pulse duration, INTn, NMI low for IDLE2/IDLE3 wake up	8		ns
t <sub>su(RS)</sub>	Setup time, RS before X2/CLKIN low <sup>®</sup>	6		ns
t <sub>su(BIO)</sub>	Setup time, BIO before CLKOUT low	7	10	ns
t <sub>su(INT)</sub>	Setup time, INTn, NMI, RS before CLKOUT low	8	10	ns
t <sub>su(MPMC)</sub>	Setup time, MP/MC before CLKOUT low	8		ns

<sup>†</sup> The external interrupts (INT0–INT3, NMI) are synchronized to the core CPU by way of a two-flip-flop synchronizer which samples these inputs with consecutive falling edges of CLKOUT. The input to the interrupt pins is required to represent a 1-0-0 sequence at the timing that is corresponding to three CLKOUT sampling sequences.

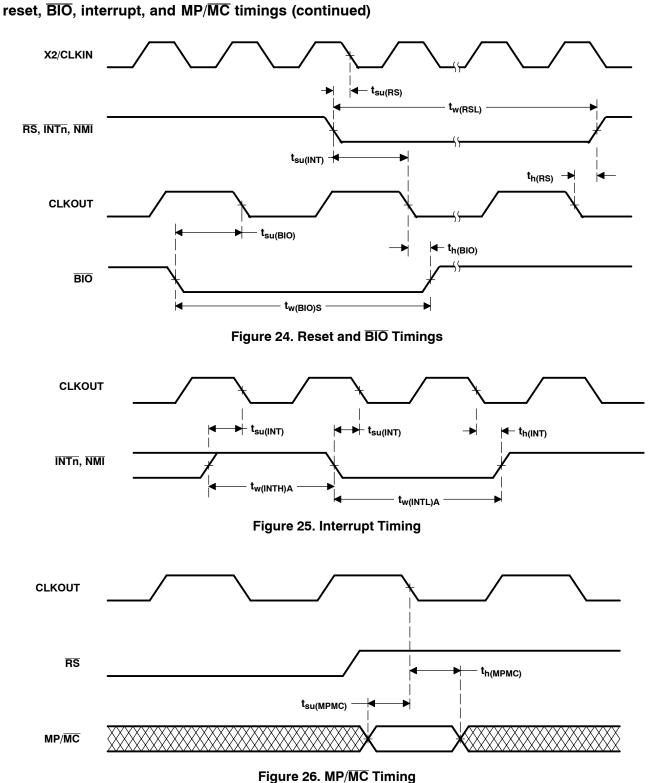
<sup>‡</sup> If the PLL mode is selected, then at power-on sequence, or at wake up from IDLE3, RS must be held low for at least 50 μs to ensure synchronization and lock-in of the PLL.

§ Note that RS may cause a change in clock frequency, therefore changing the value of H.

<sup>¶</sup> Divide-by-two mode



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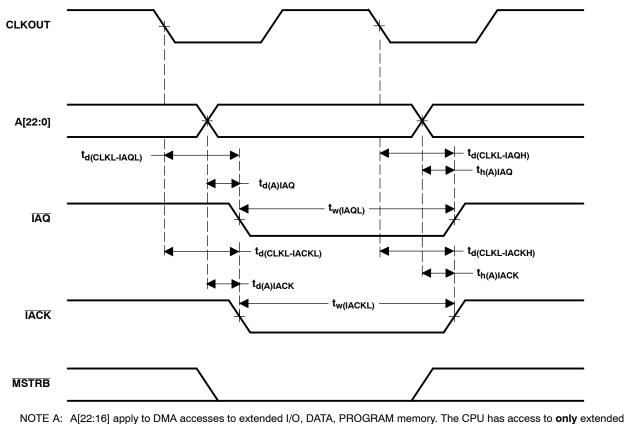


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instruction acquisition (IAQ), interrupt acknowledge (IACK), external flag (XF), and TOUT timings

# switching characteristics over recommended operating conditions for $\overline{IAQ}$ and $\overline{IACK}$ [H = 0.5 $t_{c(CO)}$ ] (see Figure 27)

	PARAMETER	MIN	MAX	UNIT
t <sub>d(CLKL-IAQL)</sub>	Delay time, CLKOUT low to IAQ low	0	3	ns
t <sub>d(CLKL-IAQH)</sub>	Delay time, CLKOUT low to IAQ high	0	3	ns
t <sub>d(A)IAQ</sub>	Delay time, address valid to IAQ low		1	ns
t <sub>d(CLKL-IACKL)</sub>	Delay time, CLKOUT low to IACK low	0	3	ns
t <sub>d(CLKL-IACKH)</sub>	Delay time , CLKOUT low to IACK high	0	3	ns
t <sub>d(A)IACK</sub>	Delay time, address valid to IACK low		1	ns
t <sub>h(A)IAQ</sub>	Hold time, IAQ high after address invalid	- 2		ns
t <sub>h(A)IACK</sub>	Hold time, IACK high after address invalid	- 2		ns
t <sub>w(IAQL)</sub>	Pulse duration, IAQ low	2H-2		ns
t <sub>w(IACKL)</sub>	Pulse duration, IACK low	2H-2		ns



PROGRAM memory.

Figure 27. IAQ and IACK Timings



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instruction acquisition (IAQ), interrupt acknowledge (IACK), external flag (XF), and TOUT timings (continued)

switching characteristics over recommended operating conditions for XF and TOUT [H = 0.5  $t_{c(CO)}$ ] (see Figure 28 and Figure 29)

	PARAMETER		MAX	UNIT
t <sub>d(XF)</sub>	Delay time, CLKOUT low to XF high	0	2	
	Delay time, CLKOUT low to XF low	0	2	ns
t <sub>d(TOUTH)</sub>	Delay time, CLKOUT low to TOUT high	0	4	ns
t <sub>d(TOUTL)</sub>	Delay time, CLKOUT low to TOUT low	0	4	ns
t <sub>w(TOUT)</sub>	Pulse duration, TOUT	2H		ns

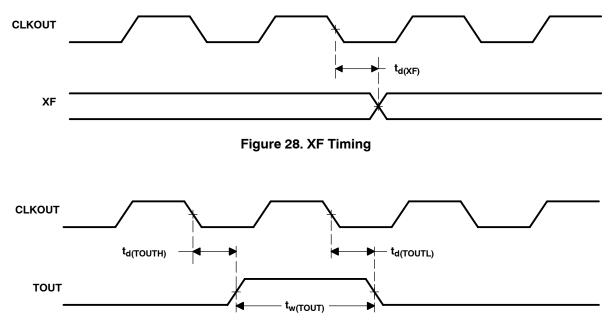


Figure 29. TOUT Timing



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#### multichannel buffered serial port timing

## timing requirements for the McBSP<sup> $\dagger$ </sup> [H=0.5t<sub>c(CO)</sub>] (see Figure 30 and Figure 31)

			MIN	MAX	UNIT
t <sub>c(BCKRX)</sub>	Cycle time, BCLKR/X	BCLKR/X ext	4H		ns
t <sub>w(BCKRX)</sub>	Pulse duration, BCLKR/X or BCLKR/X high	BCLKR/X ext	2H-1		ns
		BCLKR int	0		
t <sub>h(BCKRL-BFRH)</sub>	Hold time, external BFSR high after BCLKR low	BCLKR ext	4		ns
		BCLKR int	0		
t <sub>h(BCKRL-BDRV)</sub>	Hold time, BDR valid after BCLKR low	BCLKR ext	4		ns
t <sub>h(BCKXL-BFXH)</sub>	Hold time, external BFSX high after BCLKX low	BCLKX int	0		
		BCLKX ext	4		ns
		BCLKR int	7		
t <sub>su(BFRH-BCKRL)</sub>	Setup time, external BFSR high before BCLKR low	BCLKR ext	2		ns
		BCLKR int	7		
t <sub>su(BDRV-BCKRL)</sub>	Setup time, BDR valid before BCLKR low	BCLKR ext	2		ns
		BCLKX int	7		
t <sub>su(BFXH-BCKXL)</sub>	Setup time, external BFSX high before BCLKX low	BCLKX ext	2		ns
t <sub>r(BCKRX)</sub>	Rise time, BCKR/X	BCLKR/X ext		8	ns
t <sub>f(BCKRX)</sub>	Fall time, BCKR/X	BCLKR/X ext		8	ns

<sup>†</sup> Polarity bits CLKRP = CLKXP = FSRP = FSXP = 0. If the polarity of any of the signals is inverted, then the timing references of that signal are also inverted.



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### multichannel buffered serial port timing (continued)

## switching characteristics for the McBSP<sup> $\dagger$ </sup> [H=0.5t<sub>c(CO)</sub>] (see Figure 30 and Figure 31)

	PARAMETER			MIN	MAX	UNIT
t <sub>c(BCKRX)</sub>	Cycle time, BCLKR/X		BCLKR/X int	4H		ns
t <sub>w(BCKRXH)</sub>	Pulse duration, BCLKR/X high		BCLKR/X int	D-3 <sup>‡</sup>	D+1‡	ns
t <sub>w(BCKRXL)</sub>	Pulse duration, BCLKR/X low		BCLKR/X int	C-3‡	C+1‡	ns
t <sub>d(BCKRH-BFRV)</sub>	Delay time, BCLKR high to internal BFSR valid		BCLKR int	-2	2	ns
t <sub>d(BCKXH-BFXV)</sub>	Delay time, BCLKX high to internal BFSX valid		BCLKX int	0	6	ns
	BOL	BCLKX ext	4	12		
+	Disable time, BCLKY high to BDY high impodence follow	vina laat data hit	BCLKX int	-4	7	20
tdis(BCKXH-BDXHZ)	CKXH-BDXHZ) Disable time, BCLKX high to BDX high impedance following last data bi		BCLKX ext	3	9	ns
	Delay time, BCLKX high to BDX valid. This applies to all bits except the first bit transmitted.		BCLKX int	0	7	
			BCLKX ext	4	12	
t <sub>d(BCKXH-BDXV)</sub>	Delay time, BCLKX high to BDX valid. <sup>¶§</sup> Only applies to first bit transmitted when in Data Delay 1	DXENA = 0	BCLKX int		7	ns
	or 2 (XDATDLY=01b or 10b) modes	DAENA = 0	BCLKX ext		12	
	Enable time, BCLKX high to BDX driven. <sup>1§</sup> Only applies to first bit transmitted when in Data Delay 1	DXENA = 0	BCLKX int	-4		
t <sub>e</sub> (BCKXH-BDX)	or 2 (XDATDLY=01b or 10b) modes	DAENA = 0	BCLKX ext	2		ns
	Delay time, BFSX high to BDX valid. <sup>1§</sup>		BFSX int		2	
t <sub>d</sub> (BFXH-BDXV)	Only applies to first bit transmitted when in Data Delay 0 (XDATDLY=00b) mode.	DXENA = 0	BFSX ext		12	ns
	Enable time, BFSX high to BDX driven. <sup>1§</sup>		BFSX int	-1		
t <sub>e(BFXH-BDX)</sub>	Only applies to first bit transmitted when in Data Delay 0 (XDATDLY=00b) mode	DXENA = 0	BFSX ext	2		ns

<sup>†</sup> Polarity bits CLKRP = CLKXP = FSRP = FSXP = 0. If the polarity of any of the signals is inverted, then the timing references of that signal are also inverted.

<sup>‡</sup> T=BCLKRX period = (1 + CLKGDV) \* 2H

C=BCLKRX low pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2) \* 2H when CLKGDV is even

D=BCLKRX high pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2 + 1) \* 2H when CLKGDV is even

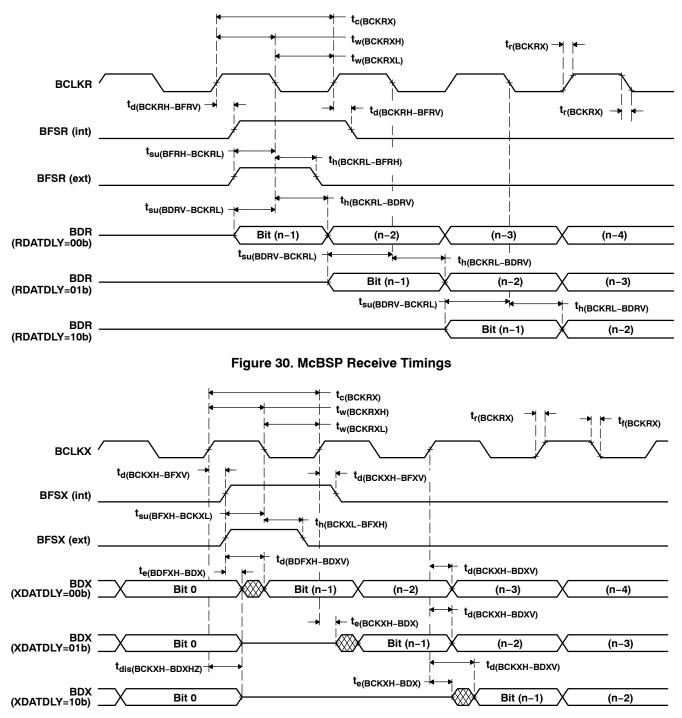
§ See the TMS320C54x Enhanced Peripherals Reference Set, Volume 5 (literature number SPRU302) for a description of the DX enable (DXENA) and data delay features of the McBSP.

<sup>¶</sup> The transmit delay enable (DXENA) and A-bis mode (ABIS) features of the McBSP are not implemented on the 320VC5409.



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#### multichannel buffered serial port timing (continued)







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### multichannel buffered serial port timing (continued)

#### timing requirements for McBSP general-purpose I/O (see Figure 32)

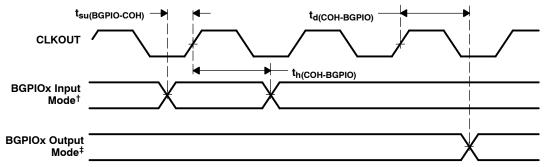
		MIN	MAX	UNIT
t <sub>su(BGPIO-COH)</sub>	Setup time, BGPIOx input mode before CLKOUT high <sup>†</sup>	9		ns
t <sub>h(COH-BGPIO)</sub>	Hold time, BGPIOx input mode after CLKOUT high <sup>†</sup>	0		ns
1				

<sup>†</sup> BGPIOx refers to BCLKRx, BFSRx, BDRx, BCLKXx, or BFSXx when configured as a general-purpose input.

#### switching characteristics for McBSP general-purpose I/O (see Figure 32)

PARAMETER	MIN	MAX	UNIT
$t_{d(COH-BGPIO)}$ Delay time, CLKOUT high to BGPIOx output mode <sup>‡</sup>	-10	10	ns

<sup>‡</sup> BGPIOx refers to BCLKRx, BFSRx, BCLKXx, BFSXx, or BDXx when configured as a general-purpose output.



<sup>†</sup> BGPIOx refers to BCLKRx, BFSRx, BDRx, BCLKXx, or BFSXx when configured as a general-purpose input. <sup>‡</sup> BGPIOx refers to BCLKRx, BFSRx, BCLKXx, BFSXx, or BDXx when configured as a general-purpose output.

#### Figure 32. McBSP General-Purpose I/O Timings



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### multichannel buffered serial port timing (continued)

#### timing requirements for McBSP as SPI master or slave: [H=0.5t<sub>c(CO)</sub>] CLKSTP = 10b, CLKXP = 0<sup>†</sup> (see Figure 33)

		MAS	MASTER		SLAVE		
		MIN	MAX	MIN	MAX	UNIT	
t <sub>su(BDRV-BCKXL)</sub>	Setup time, BDR valid before BCLKX low	10		– 12H		ns	
t <sub>h(BCKXL-BDRV)</sub>	Hold time, BDR valid after BCLKX low	0		5 + 12H		ns	
t <sub>su(BFXL-BCKXH)</sub>	Setup time, BFSX low before BCLKX high			10		ns	
t <sub>c(BCKX)</sub>	Cycle time, BCLKX	12H		32H		ns	

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

## switching characteristics for McBSP as SPI master or slave: [H=0.5t<sub>c(CO)</sub>] CLKSTP = 10b, CLKXP = $0^{\dagger}$ (see Figure 33)

	PARAMETER	MAS	TER‡	SL	AVE	UNIT
	PARAMETER	MIN	MAX	MIN	MAX	UNIT
t <sub>h(BCKXL-BFXL)</sub>	Hold time, BFSX low after BCLKX low§	T – 4	T + 4			ns
t <sub>d(BFXL-BCKXH)</sub>	Delay time, BFSX low to BCLKX high <sup>¶</sup>	C – 5	C + 3			ns
t <sub>d(BCKXH-BDXV)</sub>	Delay time, BCLKX high to BDX valid	- 3	7	6H + 5	10H + 14	ns
t <sub>dis(BCKXL-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BCLKX low	C – 2	C + 3			ns
t <sub>dis(BFXH-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BFSX high			2H+ 3	6H + 17	ns
t <sub>d(BFXL-BDXV)</sub>	Delay time, BFSX low to BDX valid			4H + 2	8H + 17	ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

<sup>‡</sup>T = BCLKX period = (1 + CLKGDV) \* 2H

C = BCLKX low pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2) \* 2H when CLKGDV is even

§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

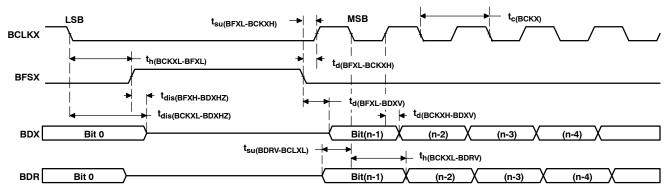


Figure 33. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 0



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### multichannel buffered serial port timing (continued)

timing requirements for McBSP as SPI master or slave:  $[H=0.5t_{c(CO)}]$  CLKSTP = 11b, CLKXP = 0<sup>†</sup> (see Figure 34)

		MAS	TER	SLAV		
		MIN	MAX	MIN	MAX	UNIT
t <sub>su(BDRV-BCKXL)</sub>	Setup time, BDR valid before BCLKX low	10		– 12H		ns
t <sub>h(BCKXH-BDRV)</sub>	Hold time, BDR valid after BCLKX high	0		5 + 12H		ns
t <sub>su(BFXL-BCKXH)</sub>	Setup time, BFSX low before BCLKX high			10		ns
t <sub>c(BCKX)</sub>	Cycle time, BCLKX			32H		ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

# switching characteristics for McBSP as SPI master or slave: $[H=0.5t_{c(CO)}]$ CLKSTP = 11b, CLKXP = 0<sup>+</sup> (see Figure 34)

	DADAMETED	MAS	TER‡	SL	AVE	
	PARAMETER	MIN	MAX	MIN	MAX	UNIT
t <sub>h(BCKXL-BFXL)</sub>	Hold time, BFSX low after BCLKX low§	C – 4	C + 4			ns
t <sub>d(BFXL-BCKXH)</sub>	Delay time, BFSX low to BCLKX high <sup>¶</sup>	T – 5	T + 3			ns
t <sub>d(BCKXL-BDXV)</sub>	Delay time, BCLKX low to BDX valid	- 3	7	6H + 5	10H + 14	ns
t <sub>dis(BCKXL-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BCLKX low	- 2	4	6H + 3	10H + 17	ns
t <sub>d(BFXL-BDXV)</sub>	Delay time, BFSX low to BDX valid	D – 1	D + 4	4H – 2	8H + 17	ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

<sup>‡</sup>T = BCLKX period = (1 + CLKGDV) \* 2H

C = BCLKX low pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2) \* 2H when CLKGDV is even

D = BCLKX high pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2 + 1) \* 2H when CLKGDV is even

§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

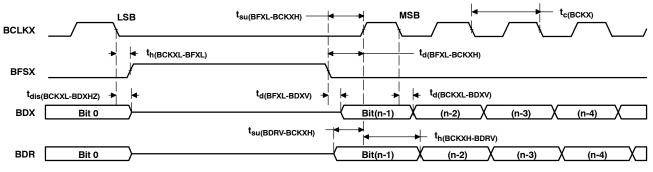


Figure 34. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 0



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#### multichannel buffered serial port timing (continued)

# timing requirements for McBSP as SPI master or slave: $[H=0.5t_{c(CO)}]$ CLKSTP = 10b, CLKXP = 1<sup>†</sup> (see Figure 35)

		MAS	TER	ER SLAVE		
		MIN	MAX	MIN	MAX	UNIT
t <sub>su(BDRV-BCKXH)</sub>	Setup time, BDR valid before BCLKX high	10		– 12H		ns
t <sub>h(BCKXH-BDRV)</sub>	Hold time, BDR valid after BCLKX high	0		5 + 12H		ns
t <sub>su(BFXL-BCKXL)</sub>	Setup time, BFSX low before BCLKX low			10		ns
t <sub>c(BCKX)</sub>	Cycle time, BCLKX			32H		ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

# switching characteristics for McBSP as SPI master or slave: $[H=0.5t_{c(CO)}]$ CLKSTP = 10b, CLKXP = 1<sup>†</sup> (see Figure 35)

	RADAMETER	MAS	TER‡	SL	AVE	
	PARAMETER	MIN	MAX	MIN	MAX	UNIT
t <sub>h(BCKXH-BFXL)</sub>	Hold time, BFSX low after BCLKX high§	T – 4	T + 4			ns
t <sub>d(BFXL-BCKXL)</sub>	Delay time, BFSX low to BCLKX low <sup>¶</sup>	D – 5	D + 3			ns
t <sub>d(BCKXL-BDXV)</sub>	Delay time, BCLKX low to BDX valid	- 3	7	6H + 5	10H + 14	ns
t <sub>dis(BCKXH-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BCLKX high	D – 2	D + 3			ns
t <sub>dis(BFXH-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BFSX high			2H + 3	6H + 17	ns
t <sub>d(BFXL-BDXV)</sub>	Delay time, BFSX low to BDX valid			4H – 2	8H + 17	ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

<sup>‡</sup>T = BCLKX period = (1 + CLKGDV) \* 2H

D = BCLKX high pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2 + 1) \* 2H when CLKGDV is even

§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

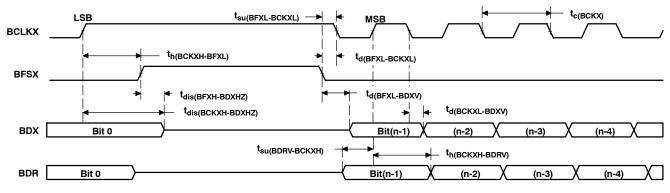


Figure 35. McBSP Timing as SPI Master or Slave: CLKSTP = 10b, CLKXP = 1



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### multichannel buffered serial port timing (continued)

timing requirements for McBSP as SPI master or slave:  $[H=0.5t_{c(CO)}]$  CLKSTP = 11b, CLKXP = 1<sup>†</sup> (see Figure 36)

		MAS	TER	SLAVE		
		MIN	MAX	MIN	MAX	UNIT
t <sub>su(BDRV-BCKXL)</sub>	Setup time, BDR valid before BCLKX low	10		– 12H		ns
t <sub>h(BCKXL-BDRV)</sub>	Hold time, BDR valid after BCLKX low	0		5 + 12H		ns
t <sub>su(BFXL-BCKXL)</sub>	Setup time, BFSX low before BCLKX low			10		ns
t <sub>c(BCKX)</sub>	Cycle time, BCLKX			32H		ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

# switching characteristics for McBSP as SPI master or slave: [H=0.5t<sub>c(CO)</sub>] CLKSTP = 11b, CLKXP = $1^{+}$ (see Figure 36)

	DADAMETER	MAS	TER‡	SL	AVE	
	PARAMETER	MIN	MAX	MIN	MAX	UNIT
t <sub>h(BCKXH-BFXL)</sub>	Hold time, BFSX low after BCLKX high <sup>§</sup>	D – 4	D + 4			ns
t <sub>d(BFXL-BCKXL)</sub>	Delay time, BFSX low to BCLKX low <sup>1</sup>	T – 5	T + 3			ns
t <sub>d(BCKXH-BDXV)</sub>	Delay time, BCLKX high to BDX valid	- 3	7	6H + 5	10H + 14	ns
t <sub>dis(BCKXH-BDXHZ)</sub>	Disable time, BDX high impedance following last data bit from BCLKX high	- 2	4	6H + 3	10H + 17	ns
t <sub>d(BFXL-BDXV)</sub>	Delay time, BFSX low to BDX valid	C – 1	C + 4	4H – 2	8H + 17	ns

<sup>†</sup> For all SPI slave modes, CLKG is programmed as 1/2 of the CPU clock by setting CLKSM = CLKGDV = 1.

<sup>‡</sup>T = BCLKX period = (1 + CLKGDV) \* 2H

C = BCLKX low pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2) \* 2H when CLKGDV is even

D = BCLKX high pulse width = T/2 when CLKGDV is odd or zero and = (CLKGDV/2 + 1) \* 2H when CLKGDV is even

§ FSRP = FSXP = 1. As a SPI master, BFSX is inverted to provide active-low slave-enable output. As a slave, the active-low signal input on BFSX and BFSR is inverted before being used internally.

CLKXM = FSXM = 1, CLKRM = FSRM = 0 for master McBSP

CLKXM = CLKRM = FSXM = FSRM = 0 for slave McBSP

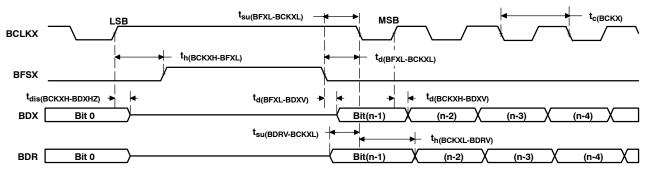


Figure 36. McBSP Timing as SPI Master or Slave: CLKSTP = 11b, CLKXP = 1



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#### HPI8 timing

# switching characteristics over recommended operating conditions<sup> $\pm$ §¶</sup> [H = 0.5t<sub>c(CO)</sub>] (see Figure 37, Figure 38, Figure 40, and Figure 41)

	PARAMETER		MIN MAX	UNIT
t <sub>en(DSL-HD)</sub>	Enable time, HD driven from DS low		2 19	ns
		Case 1a: Memory accesses when DMAC is active in 16-bit mode and $t_{\rm w(DSH)} < 18 \rm H$	18H+19 - t <sub>w(DSH)</sub>	
		Case 1b: Memory accesses when DMAC is active in 16-bit mode and $t_{w(DSH)} \geq 18H$	19	
	Delay time, DS low to HDx valid for	Case 1c: Memory access when DMAC is active in 32-bit mode and $t_{w(\text{DSH})} < 26\text{H}$	sees when mode and19when mode and $26H+19 - t_{w(DSH)}$ when mode and $19$ when mode and $19$ sees when DSH) < 10H	
t <sub>d(DSL-HDV1)</sub>	first byte of an HPI read	Case 1d: Memory access when DMAC is active in 32-bit mode and $t_{w(DSH)} \geq 26H$	19	ns
		Case 2a: Memory accesses when DMAC is inactive and $t_{w(DSH)}$ < 10H	10H+19 - t <sub>w(DSH)</sub>	
		Case 2b: Memory accesses when DMAC is inactive and $t_{w(DSH)} \geq 10 H$	19	
		Case 3: Register accesses	19	
t <sub>d(DSL-HDV2)</sub>	Delay time, DS low to HDx valid for se	econd byte of an HPI read	19	ns
t <sub>h(DSH-HDV)</sub> R	Hold time, HDx valid after DS high, fo	r a HPI read	3 5	ns
t <sub>v(HYH-HDV)</sub>	Valid time, HDx valid after HRDY high	l	5	
t <sub>d(DSH-HYL)</sub>	Delay time, DS high to HRDY low (se	e Note 1)	10	ns
		Case 1a: Memory accesses when DMAC is active in 16-bit mode	18H+10	ns
		Case 1b: Memory accesses when DMAC is active in 32-bit mode	26H+10	ns
t <sub>d(DSH-HYH)</sub>	Delay time, DS high to HRDY high	Case 2: Memory accesses when DMAC is inactive	10H+10	
		Case 3: Write accesses to HPIC register (see Note 2)	6H+10	ns
t <sub>d(HCS-HRDY)</sub>	Delay time, HCS low/high to HRDY lo	w/high	15	ns
t <sub>d(СОН-НҮН</sub> )	Delay time, CLKOUT high to HRDY h	igh	2	ns
t <sub>d(COH-HTX)</sub>	Delay time, CLKOUT high to HINT ch	ange	5	ns

NOTES: 1. The HRDY output is always high when the HCS input is high, regardless of DS timings.

2. This timing applies when writing a one to the DSPINT bit or HINT bit of the HPIC register. All other writes to the HPIC occur asynchronously, and do not cause HRDY to be deasserted.

<sup>†</sup> DS refers to the logical OR of HCS, HDS1, and HDS2.

<sup>‡</sup> HDx refers to any of the HPI data bus pins (HD0, HD1, HD2, etc.).

§ DMAC stands for direct memory access (DMA) controller. The HPI8 shares the internal DMA bus with the DMAC, thus HPI8 access times are affected by DMAC activity.

<sup>¶</sup> GPIO refers to the HD pins when they are configured as general-purpose input/outputs.



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### HPI8 timing (continued)

## timing requirements<sup>†‡§</sup> (see Figure 37, Figure 38, Figure 40, and Figure 41)

		MIN	MAX	UNIT
t <sub>su(HBV-DSL)</sub>	Setup time, HBIL valid before DS low	5		ns
t <sub>h(DSL-HBV)</sub>	Hold time, HBIL valid after DS low	5		ns
t <sub>su(HSL-DSL)</sub>	Setup time, HAS low before DS low	5		ns
t <sub>w(DSL)</sub>	Pulse duration, DS low	20		ns
t <sub>w(DSH)</sub>	Pulse duration, DS high	10		ns
t <sub>su(HDV-DSH)</sub>	Setup time, HDx valid before DS high, HPI write	5		ns
t <sub>h(DSH-HDV)W</sub>	Hold time, HDx valid after DS high, HPI write	5		ns

<sup>†</sup> DS refers to the logical OR of HCS, HDS1, and HDS2.
 <sup>‡</sup> HDx refers to any of the HPI data bus pins (HD0, HD1, HD2, etc.).

§ GPIO refers to the HD pins when they are configured as general-purpose input/outputs.



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#### HPI8 timing (continued)

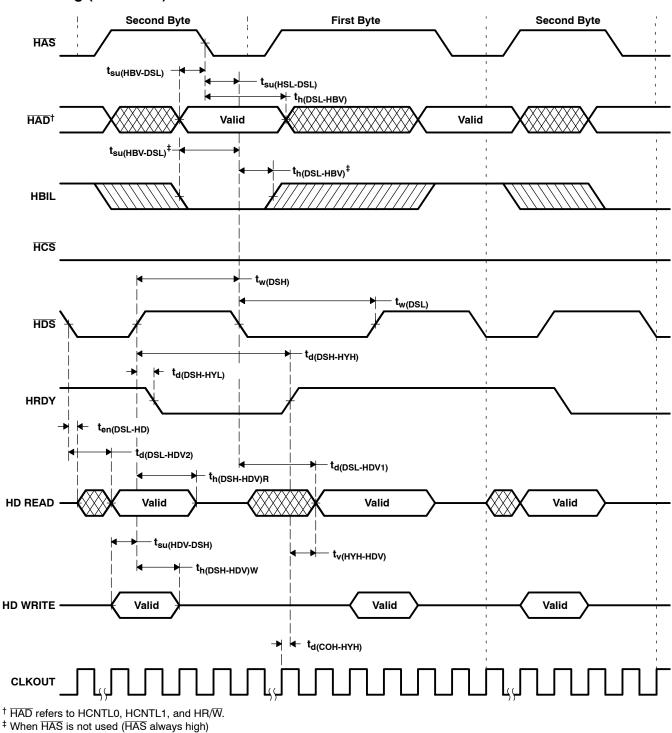
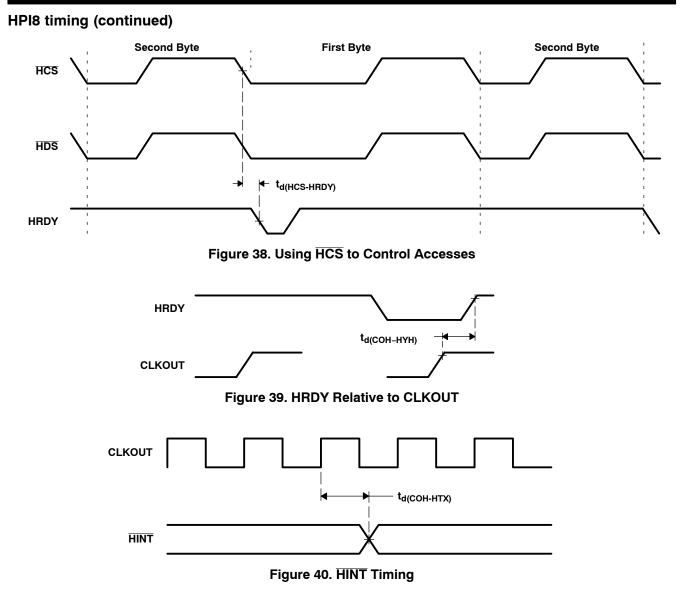


Figure 37. Using HDS to Control Accesses (HCS Always Low)



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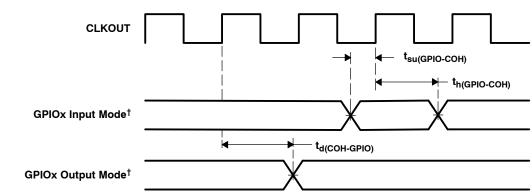
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### timing requirements for GPIO (see Figure 41)

		MIN	MAX	UNIT
t <sub>su(GPIO-COH)</sub>	Setup time, GPIOx input valid before CLKOUT high, GPIOx configured as general-purpose input.	7		ns
t <sub>h(GPIO-COH)</sub>	Hold time, GPIOx input valid after CLKOUT high, GPIOx configured as general-purpose input.	0		ns

### switching characteristics for GPIO (see Figure 41)

	MIN	MAX	UNIT	
t <sub>d</sub> (COH-GPIO)	Delay time, CLKOUT high to GPIOx output change. GPIOx configured as general-purpose output.	0	6	ns



<sup>†</sup> GPIOx refers to HD0, HD1, HD2, ...HD7, when the HD bus is configured for general-purpose input/output (I/O).

Figure 41. GPIOx<sup>†</sup> Timings



#### HPI16 timing

# switching characteristics over recommended operating conditions<sup> $\dagger$ +§¶</sup> [H = 0.5t<sub>c(CO)</sub>] (see Figure 42 and Figure 43)

PARAMETER				MAX	UNIT	
t <sub>en(DSL-HD)</sub>	Enable time, Dx driven from DS low	6	19	ns		
t <sub>d(DSL-HDV1)</sub>		Case 1a: Memory accesses when DMAC is active in 16-bit mode and $t_{w(DSH)} < 18H$	18H+19 - t <sub>w(DSH)</sub> 19 10H+19 - t <sub>w(DSH)</sub>			
	Delay time, DS low to Dx valid for an HPI read	Case 1b: Memory accesses when DMAC is active in 16-bit mode and $t_{w(DSH)} \ge 18H$			ns	
		Case 2a: Memory accesses when DMAC is inactive and $t_{w(DSH)}$ < 10H				
		Case 2b: Memory accesses when DMAC is inactive and $t_{w(DSH)} \geq 10 \text{H}$		19	1	
		Case 3: Register accesses		19		
t <sub>h(DSH-HDV)R</sub>	Hold time, Dx valid after DS rising edge	e, read <sup>§</sup>	1	8	ns	
tv <sub>(HYH-HDV)</sub>	Valid time, Dx valid before HRDY rising	edge	0	6	ns	
t <sub>d(DSH-HYL)</sub>	Delay time, DS or HCS high to HRDY le	ow‡		10	ns	
t <sub>d(DSH-HYH)</sub>	Delay time, DS high to HRDY high <sup>§</sup> (writes and autoincrement reads)	Case 1: Memory access when DMAC is active in 16-bit mode	C 18H+10			
		Case 2: Memory access when DMAC is inactive		10H+10	ns	
t <sub>d(DSL-HYL)</sub>	Delay time, HDS or HCS low/high to HI	RDY low/high		10	ns	
t <sub>d(COH-HYH)</sub>	Delay time, CLKOUT high to HRDY high			2	ns	

NOTE: The HRDY output is always high when the HCS input is high, regardless of DS timings.

<sup>†</sup> DS refers to the logical OR of  $\overline{\text{HCS}}$ ,  $\overline{\text{HDS1}}$ , or  $\overline{\text{HDS2}}$ .

<sup>‡</sup> Dx refers to any of the DPI data bus pins (D0, D1, D2, etc.).

§ DMAC stands for direct memory access (DMA) controller. The HPI16 shares the internal DMA bus with the DMAC, thus HPI16 access times are affected by DMAC activity.

 $^{\P}$  GPIO refers to the HD pins when they are configured as general-purpose input/outputs.



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### HPI16 timing (continued)

## timing requirements<sup> $\ddagger$ </sup> [H = 0.5t<sub>c(CO)</sub>] (see Note 1, Figure 42, and Figure 43)

			MIN	MAX	UNIT
t <sub>su(HBV-DSL)</sub>	Setup time, HAD valid before DS falling edge <sup>†‡</sup>	5		ns	
t <sub>h(DSL-HBV)</sub>	Hold time, HAD valid after DS falling edge <sup>†‡</sup>		5		ns
t <sub>su(HAV-DSL)</sub>	Setup time, HAD valid before DS falling edge $^{\dagger}$		-4H+3		ns
t <sub>h(DSH-HAV)</sub>	Hold time, address valid after DS rising $edge^\dagger$	1		ns	
t <sub>su(HDV-DSH)</sub>	Setup time, Dx valid before DS high (HPI write)	3		ns	
t <sub>h(DSH-HDV)W</sub>	Hold time, Dx valid after DS high (HPI write)	2		ns	
t <sub>w(DSL)</sub>	Pulse duration, DS low <sup>‡</sup>	20		ns	
t <sub>w(DSH)</sub>	Pulse duration, DS high <sup>‡</sup>		10		ns
	Cycle time, DS rising edge to next DS rising edge <sup><math>\ddagger</math></sup>	Nonmultiplexed mode (no increment) with no DMA activity.	12H		ns
t <sub>c(DSH-DSH)</sub>	(Minimum timings represent WRITEs while maximum timings represent READs)	Nonmultiplexed mode (no increment) with 16-bit DMA activity.	20H		ns

<sup>†</sup> DS refers to the logical OR of  $\overline{\text{HCS}}$  and  $\overline{\text{HDS1}}$  and  $\overline{\text{HDS2}}$ .

<sup>‡</sup> Dx refers to any of the HPI data bus pins (D0, D1, D2, etc.).

§ GPIO refers to the HD pins when they are configured as general-purpose input/outputs.



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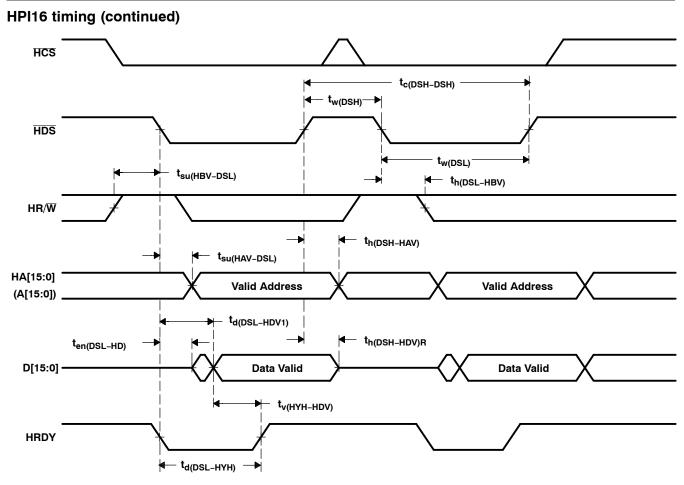


Figure 42. Nonmultiplexed Read Timings



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#### HPI16 timing (continued)

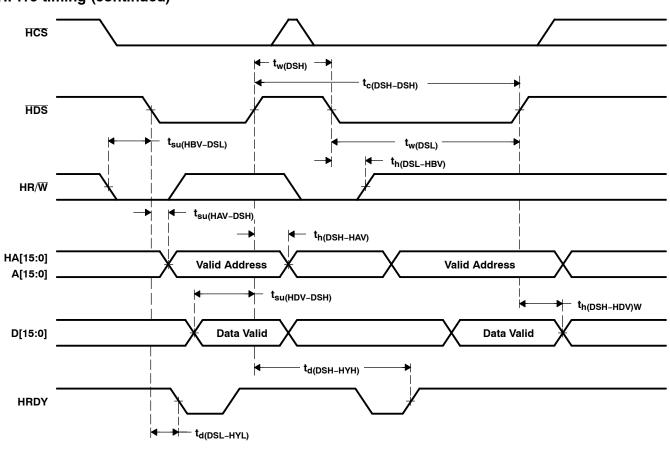


Figure 43. Nonmultiplexed Write Timings

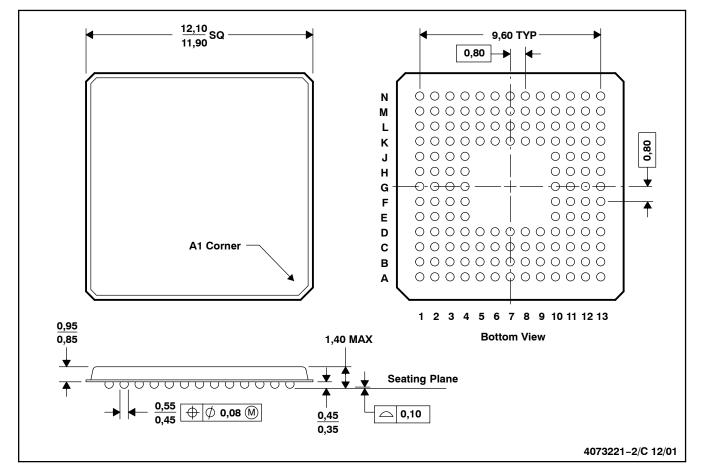


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#### MECHANICAL DATA

GGU (S-PBGA-N144)

#### PLASTIC BALL GRID ARRAY PACKAGE



NOTES: B. All linear dimensions are in millimeters.

- C. This drawing is subject to change without notice.
- D. MicroStar BGA™ configuration

#### Thermal Resistance Characteristics

PARAMETER	°C/W			
$R_{\ThetaJA}$	38			
$R_{\Theta JC}$	5			

MicroStar BGA is a trademark of Texas Instruments Incorporated.

### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SM320VC5409GGU10EP	ACTIVE	BGA	GGU	144	189	TBD	SNPB	Level-3-220C-168 HR
V62/04649-01XA	ACTIVE	BGA	GGU	144	189	TBD	SNPB	Level-3-220C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

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NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

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**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

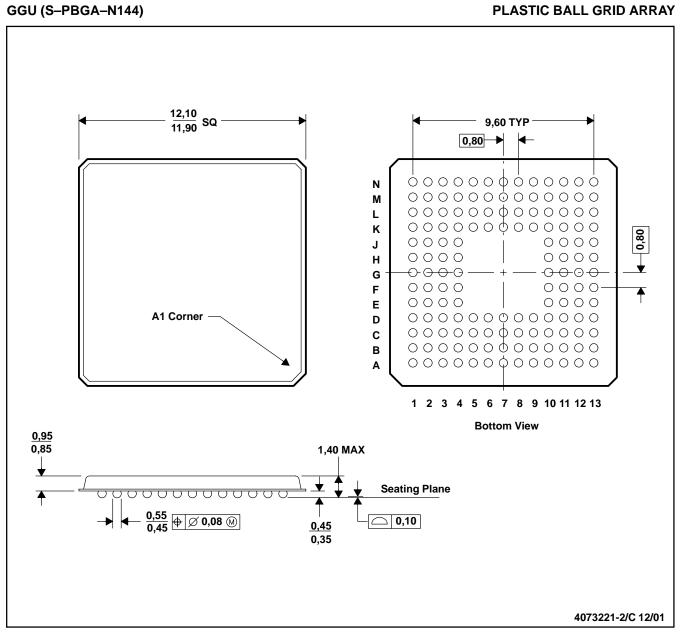
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## **MECHANICAL DATA**

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